IBM

64Mb Synchronous DRAM - Die Revision B

Features

- High Performance:

		-68, CL=3	-260, CL=3	-360, CL=3	-10, CL=3	Units
f_{CK}	Clock Frequency	147	135	135	100	MHz
t_{CK}	Clock Cycle	6.8	7.4	7.4	10	ns
t_{AC}	Clock Access Time[1]	6	—	—	7	ns
t_{AC}	Clock Access Time[2]	—	6	6	9	ns

1. Terminated load. See AC Characteristics on page 44.
2. Unterminated load. See AC Characteristics on page 44.

- Single Pulsed $\overline{RAS}$ Interface
- Fully Synchronous to Positive Clock Edge
- Four Banks controlled by A12/A13 (Bank Select)
- Programmable CAS Latency: 2, 3
- Programmable Burst Length: 1, 2, 4, 8, full-page

- Programmable Wrap: Sequential or Interleave
- Multiple Burst Read with Single Write Option
- Automatic and Controlled Precharge Command
- Data Mask for Read/Write control (x4, x8)
- Dual Data Mask for byte control (x16)
- Auto Refresh (CBR) and Self Refresh
- Suspend Mode and Power Down Mode
- Standard or Low Power operation
- 4096 refresh cycles/64ms
- Random Column Address every CLK (1-N Rule)
- Single 3.3V $\pm$ 0.3V Power Supply
- LVTTL compatible
- Package: 54-pin 400 mil TSOP-Type II
             2 High Stack TSOJ

Description

The IBM0364404, IBM0364804, and IBM0364164 are four-bank Synchronous DRAMs organized as 4Mbit x 4 I/O x 4 Bank, 2Mbit x 8 I/O x 4 Bank, and 1Mbit x 16 I/O x 4 Bank, respectively. IBM03644B4, a stacked version of the x4 component, is also offered. These synchronous devices achieve high-speed data transfer rates of up to 147MHz by employing a pipeline chip architecture that synchronizes the output data to a system clock. The chip is fabricated with IBM's advanced 64Mbit single transistor CMOS DRAM process technology.

The device is designed to comply with all JEDEC standards for synchronous DRAM products, both electrically and mechanically. All the control, address, and data input/output (I/O or DQ) circuits are synchronized with the positive edge of an externally supplied clock.

$\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, and $\overline{CS}$ are pulsed signals which are examined at the positive edge of each externally applied clock (CLK). Internal chip operating modes are defined by combinations of these signals, and a command decoder initiates the necessary timings for each operation. A fourteen-bit address bus accepts address data in the conventional $\overline{RAS}/\overline{CAS}$ multiplexing style. Twelve row addresses (A0-A11)

and two bank select addresses (A12, A13) are strobed with $\overline{RAS}$. Ten column addresses (A0-A9) plus bank select addresses and A10 are strobed with $\overline{CAS}$. Column address A9 is dropped on the x8 device and column addresses A8 and A9 are dropped on the x16 device. Access to the lower or upper DRAM in a stacked device is controlled by $\overline{CS0}$ and $\overline{CS1}$, respectively.

Prior to any access operation, the $\overline{CAS}$ latency, burst length, and burst sequence must be programmed into the device by address inputs A0-A13 during a mode register set cycle. In addition, it is possible to program a multiple burst sequence with single write cycle for write through cache operation.

Operating the four memory banks in an interleave fashion allows random access operation to occur at a higher rate than is possible with standard DRAMs. A sequential and gapless data rate of up to 147MHz is possible depending on burst length, $\overline{CAS}$ latency, and speed grade of the device. Simultaneous operation of both decks of a stacked device is allowed, depending on the operation being done.

Auto Refresh (CBR), Self Refresh, and Low Power operation are supported.

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IBM0364804   IBM0364164
IBM0364404   IBM03644B4
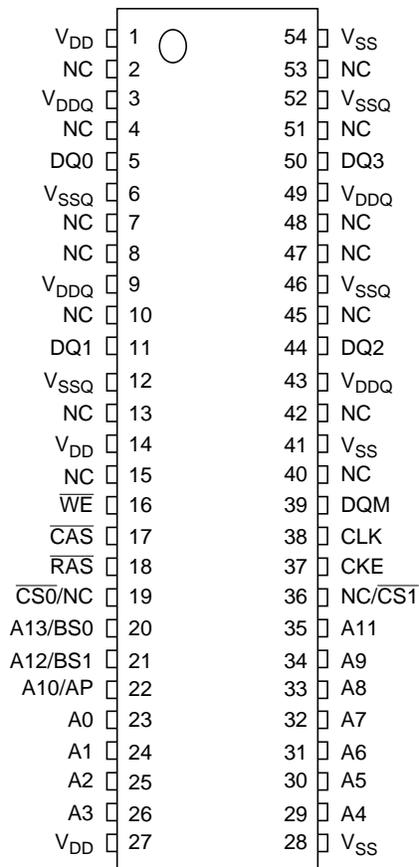**64Mb Synchronous DRAM - Die Revision B**

Pin Assignments for Planar Components (Top View)

1Mb×16	2Mb×8	4Mb×4	Pin	Pin	4Mb×4	2Mb×8	1Mb×16
V_{DD}	V_{DD}	V_{DD}	1	54	V_{SS}	V_{SS}	V_{SS}
DQ0	DQ0	NC	2	53	NC	DQ7	DQ15
V_{DDQ}	V_{DDQ}	V_{DDQ}	3	52	V_{SSQ}	V_{SSQ}	V_{SSQ}
DQ1	NC	NC	4	51	NC	NC	DQ14
DQ2	DQ1	DQ0	5	50	DQ3	DQ6	DQ13
V_{SSQ}	V_{SSQ}	V_{SSQ}	6	49	V_{DDQ}	V_{DDQ}	V_{DDQ}
DQ3	NC	NC	7	48	NC	NC	DQ12
DQ4	DQ2	NC	8	47	NC	DQ5	DQ11
V_{DDQ}	V_{DDQ}	V_{DDQ}	9	46	V_{SSQ}	V_{SSQ}	V_{SSQ}
DQ5	NC	NC	10	45	NC	NC	DQ10
DQ6	DQ3	DQ1	11	44	DQ2	DQ4	DQ9
V_{SSQ}	V_{SSQ}	V_{SSQ}	12	43	V_{DDQ}	V_{DDQ}	V_{DDQ}
DQ7	NC	NC	13	42	NC	NC	DQ8
V_{DD}	V_{DD}	V_{DD}	14	41	V_{SS}	V_{SS}	V_{SS}
LDQM	NC	NC	15	40	NC	NC	NC
$\overline{WE}$	$\overline{WE}$	$\overline{WE}$	16	39	DQM	DQM	UDQM
$\overline{CAS}$	$\overline{CAS}$	$\overline{CAS}$	17	38	CLK	CLK	CLK
$\overline{RAS}$	$\overline{RAS}$	$\overline{RAS}$	18	37	CKE	CKE	CKE
$\overline{CS}$	$\overline{CS}$	$\overline{CS}$	19	36	NC	NC	NC
A13/BS0	A13/BS0	A13/BS0	20	35	A11	A11	A11
A12/BS1	A12/BS1	A12/BS1	21	34	A9	A9	A9
A10/AP	A10/AP	A10/AP	22	33	A8	A8	A8
A0	A0	A0	23	32	A7	A7	A7
A1	A1	A1	24	31	A6	A6	A6
A2	A2	A2	25	30	A5	A5	A5
A3	A3	A3	26	29	A4	A4	A4
V_{DD}	V_{DD}	V_{DD}	27	28	V_{SS}	V_{SS}	V_{SS}

54-pin Plastic TSOP(II) 400 mil

4Mbit x 4 I/O x 4 Bank

IBM0364404

2Mbit x 8 I/O x 4 Bank

IBM0364804

1Mbit x 16 I/O x 4 Bank

IBM0364164

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IBM0364804   IBM0364164
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Pin Assignments for 2 High Stack Package (Dual CS Pin) (Top View)

Left	Pin	Pin	Right
V_{DD}	1	54	V_{SS}
NC	2	53	NC
V_{DDQ}	3	52	V_{SSQ}
NC	4	51	NC
DQ0	5	50	DQ3
V_{SSQ}	6	49	V_{DDQ}
NC	7	48	NC
NC	8	47	NC
V_{DDQ}	9	46	V_{SSQ}
NC	10	45	NC
DQ1	11	44	DQ2
V_{SSQ}	12	43	V_{DDQ}
NC	13	42	NC
V_{DD}	14	41	V_{SS}
NC	15	40	NC
$\overline{WE}$	16	39	DQM
$\overline{CAS}$	17	38	CLK
$\overline{RAS}$	18	37	CKE
$\overline{CS0}$/NC	19	36	NC/$\overline{CS1}$
A13/BS0	20	35	A11
A12/BS1	21	34	A9
A10/AP	22	33	A8
A0	23	32	A7
A1	24	31	A6
A2	25	30	A5
A3	26	29	A4
V_{DD}	27	28	V_{SS}

54-pin Plastic TSOJ(II) 400 mil

(4Mbit x 4 I/O x 4 Bank) x 2High

IBM03644B4

* $\overline{CS0}$ selects the lower DRAM in the stack.
* $\overline{CS1}$ selects the upper DRAM in the stack.

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Pin Description

CLK	Clock Input	DQ0-DQ15	Data Input/Output
CKE	Clock Enable	DQM, LDQM, UDQM	Data Mask
$\overline{CS}$ ($\overline{CS0}$, $\overline{CS1}$)	Chip Select	V_{DD}	Power (+3.3V)
$\overline{RAS}$	Row Address Strobe	V_{SS}	Ground
$\overline{CAS}$	Column Address Strobe	V_{DDQ}	Power for DQs (+3.3V)
$\overline{WE}$	Write Enable	V_{SSQ}	Ground for DQs
BS1, BS0 (A12, A13)	Bank Select	NC	No Connection
A0-A11	Address Inputs	—	—

Input/Output Functional Description

Symbol	Type	Polarity	Function
CLK	Input	Positive Edge	The system clock input. All of the SDRAM inputs are sampled on the rising edge of the clock.
CKE	Input	Active High	Activates the CLK signal when high and deactivates the CLK signal when low. By deactivating the clock, CKE low initiates the Power Down mode, Suspend mode, or the Self Refresh mode.
$\overline{CS}$, $\overline{CS0}$, $\overline{CS1}$	Input	Active Low	$\overline{CS}$ ($\overline{CS0}$, $\overline{CS1}$ for stacked devices) enables the command decoder when low and disables the command decoder when high. When the command decoder is disabled, new commands are ignored but previous operations continue.
$\overline{RAS}$, $\overline{CAS}$ $\overline{WE}$	Input	Active Low	When sampled at the positive rising edge of the clock, $\overline{CAS}$, $\overline{RAS}$, and $\overline{WE}$ define the operation to be executed by the SDRAM.
BS1, BS0 (A12, A13)	Input	—	Selects which bank is to be active.
A0 - A11	Input	—	During a Bank Activate command cycle, A0-A11 defines the row address (RA0-RA11) when sampled at the rising clock edge. During a Read or Write command cycle, A0-A9 defines the column address (CA0-CA9) when sampled at the rising clock edge. A10 is used to invoke auto-precharge operation at the end of the burst read or write cycle. If A10 is high, auto-precharge is selected and BS0, BS1 defines the bank to be precharged. If A10 is low, autoprecharge is disabled. During a Precharge command cycle, A10 is used in conjunction with BS0, BS1 to control which bank(s) to precharge. If A10 is high, all banks will be precharged regardless of the state of BS. If A10 is low, then BS0 and BS1 are used to define which bank to precharge.
DQ0-DQ15	Input-Output	—	Data Input/Output pins operate in the same manner as on conventional DRAMs.
DQM LDQM UDQM	Input	Active High	The Data Input/Output mask places the DQ buffers in a high impedance state when sampled high. In x16 products, LDQM and UDQM control the lower and upper byte I/O buffers, respectively. In Read mode, DQM has a latency of two clock cycles and controls the output buffers like an output enable. DQM low turns the output buffers on and DQM high turns them off. In Write mode, DQM has a latency of zero and operates as a word mask by allowing input data to be written if it is low but blocks the write operation if DQM is high.
V_{DD}, V_{SS}	Supply	—	Power and ground for the input buffers and the core logic.
V_{DDQ}, V_{SSQ}	Supply	—	Isolated power supply and ground for the output buffers to provide improved noise immunity.

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Ordering Information - Planar Devices (Single $\overline{CS}$ Pin)

Part Number	CAS Latencies	Power Supply	Clock Cycle	Package	Power[1]	Org.
IBM0364404CT3B-260	2, 3	3.3V	7.4ns	400mil Type II TSOP-54	SP	x4
IBM0364404CT3B-360						
IBM0364404CT3B-10			10ns			
IBM0364804CT3B-68			6.8ns			x8
IBM0364804CT3B-260			7.4ns			
IBM0364804CT3B-360						
IBM0364804CT3B-10			10ns			
IBM0364164CT3B-68			6.8ns			x16
IBM0364164CT3B-360			7.4ns			
IBM0364164CT3B-10			10ns			
IBM0364804PT3B-360	2, 3	3.3V	7.4ns	400mil Type II TSOP-54	LP	x8
IBM0364804PT3B-10			10ns			
IBM0364164PT3B-360			7.4ns			x16
IBM0364164PT3B-10			10ns			

1. SP: Standard Power; LP: Low Power.

Ordering Information - 2 High Stacked Devices (Dual $\overline{CS}$ Pin)

Part Number	CAS Latencies	Power Supply	Clock Cycle	Package	Power[1]	Org.
IBM03644B4CT3B-260	2, 3	3.3V	7.4ns	400mil Type II TSOJ-54	SP	x4
IBM03644B4CT3B-360						

1. SP: Standard Power.

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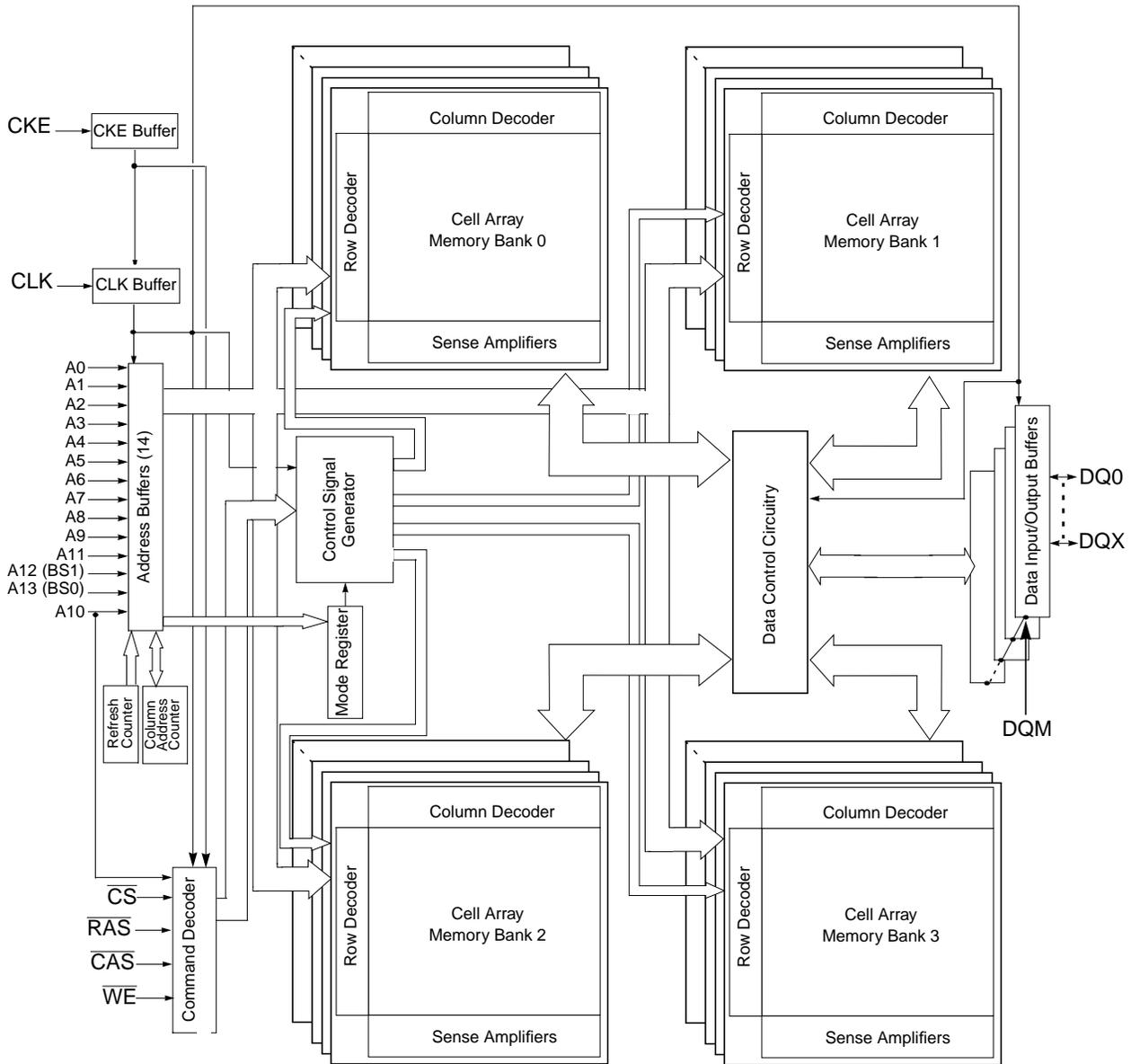
Block Diagram

Cell Array for 4Mb x 4 DQ x 4 Bank (per Bank): 4096 Row x 1024 Col x 4 DQ (DQ0-DQ3).
Cell Array for 2Mb x 8 DQ x 4 Bank (per Bank): 4096 Row x 512 Col x 8 DQ (DQ0-DQ7).
Cell Array for 1Mb x 16 DQ x 4 Bank (per Bank): 4096 Row x 256 Col x 16 DQ (DQ0-DQ15).

Block Diagram (4Mbit x 4 I/O x 4 Bank) x 2-High

$\overline{CS0}$

$\overline{CS1}$

CKE
CLK
A11-A0
BS0,BS1
$\overline{RAS}$
$\overline{CAS}$
$\overline{WE}$
DQM

4Mb x 4 I/O x 4 Bank

DQ0
DQ1
DQ2
DQ3
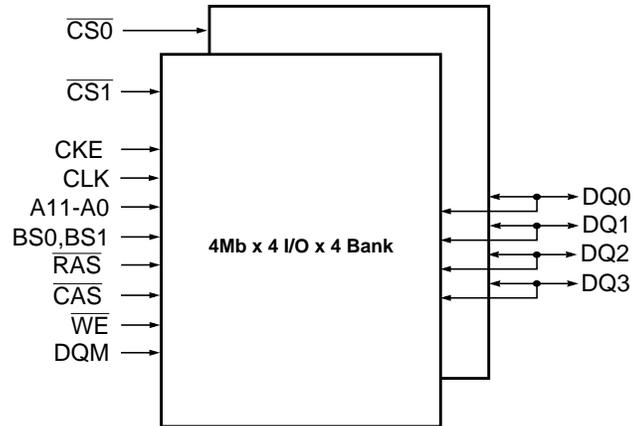
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Power On and Initialization

The default power on state of the mode register is supplier specific and may be undefined. The following power on and initialization sequence guarantees the device is preconditioned to each users specific needs.

Like a conventional DRAM, the Synchronous DRAM must be powered up and initialized in a predefined manner. During power on, all V_{DD} and V_{DDQ} pins must be built up simultaneously to the specified voltage when the input signals are held in the "NOP" state. The power on voltage must not exceed V_{DD}+0.3V on any of the input pins or V_{DD} supplies. The CLK signal must be started at the same time. After power on, an initial pause of 200µs is required followed by a precharge of all banks using the precharge command. To prevent data contention on the DQ bus during power on, it is required that the DQM and CKE pins be held high during the initial pause period. Once all banks have been precharged, the Mode Register Set Command must be issued to initialize the Mode Register. A minimum of eight Auto Refresh cycles (CBR) are also required. These may be done before or after programming the Mode Register. Failure to follow these steps may lead to unpredictable start-up modes.

Programming the Mode Register

For application flexibility, $\overline{CAS}$ latency, burst length, burst sequence, and operation type are user defined variables and must be programmed into the SDRAM Mode Register with a single Mode Register Set Command. Any content of the Mode Register can be altered by re-executing the Mode Register Set Command. If the user chooses to modify only a subset of the Mode Register variables, all four variables must be redefined when the Mode Register Set Command is issued.
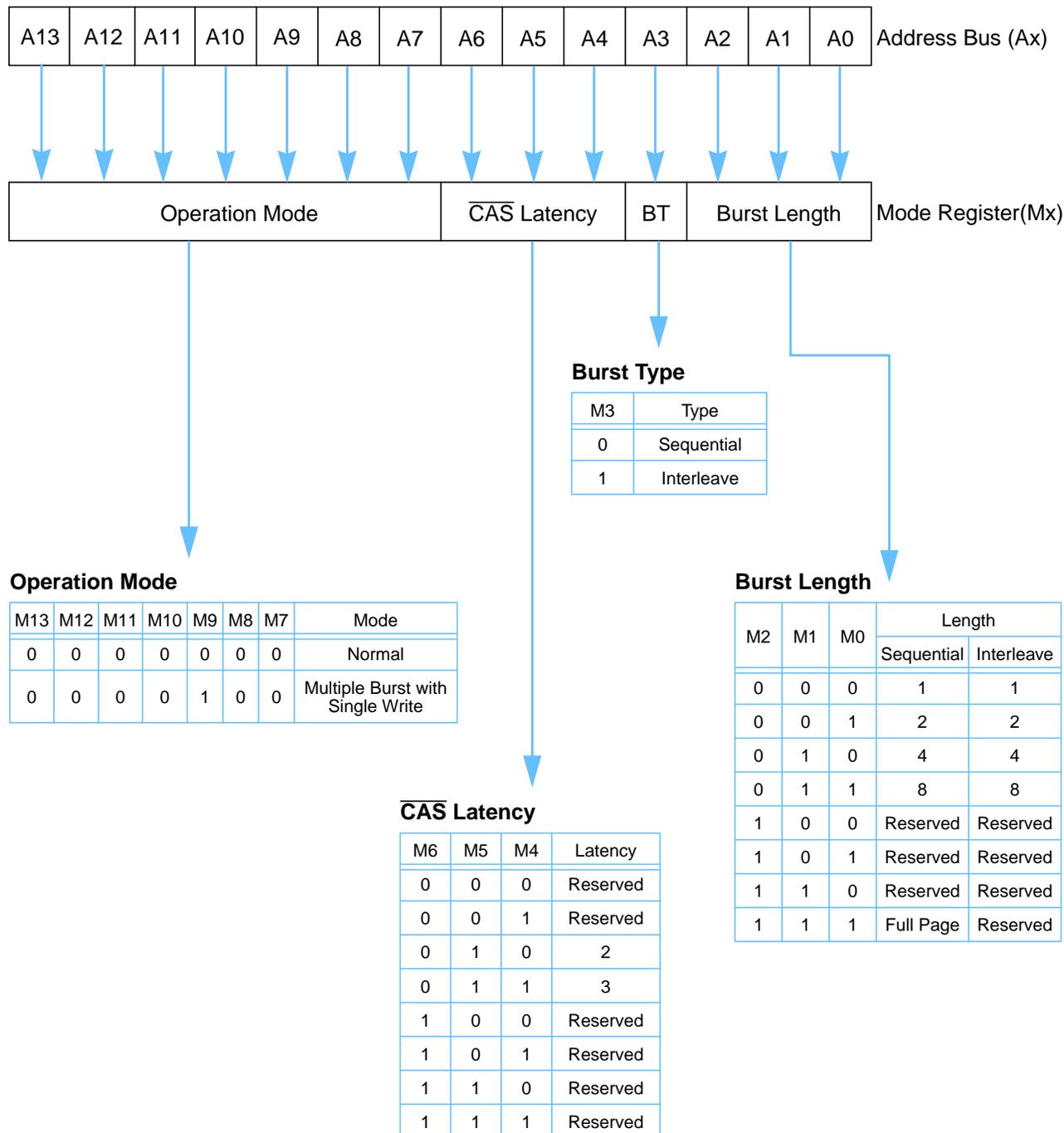
After initial power up, the Mode Register Set Command must be issued before read or write cycles may begin. All banks must be in a precharged state and CKE must be high at least one cycle before the Mode Register Set Command can be issued. The Mode Register Set Command is activated by the low signals of $\overline{RAS}$, $\overline{CAS}$, $\overline{CS}$, and $\overline{WE}$ at the positive edge of the clock. The address input data during this cycle defines the parameters to be set as shown in the Mode Register Operation table. A new command may be issued following the mode register set command once a delay equal to t_{RSC} has elapsed.

$\overline{CAS}$ Latency

The $\overline{CAS}$ latency is a parameter that is used to define the delay from when a Read Command is registered on a rising clock edge to when the data from that Read Command becomes available at the outputs. The $\overline{CAS}$ latency is expressed in terms of clock cycles and can have a value of 2 or 3 cycles. The value of the $\overline{CAS}$ latency is determined by the speed grade of the device and the clock frequency that is used in the application. A table showing the relationship between the $\overline{CAS}$ latency, speed grade, and clock frequency appears in the Electrical Characteristics section of this document. Once the appropriate $\overline{CAS}$ latency has been selected it must be programmed into the mode register after power up, for an explanation of this procedure see Programming the Mode Register in the previous section.

Mode Register Operation (Address Input For Mode Set)

| A13 | A12 | A11 | A10 | A9 | A8 | A7 | A6 | A5 | A4 | A3 | A2 | A1 | A0 | Address Bus (Ax) |

| Operation Mode | $\overline{CAS}$ Latency | BT | Burst Length | Mode Register(Mx) |

Burst Type

M3	Type
0	Sequential
1	Interleave

Operation Mode

M13	M12	M11	M10	M9	M8	M7	Mode
0	0	0	0	0	0	0	Normal
0	0	0	0	1	0	0	Multiple Burst with Single Write

Burst Length

M2	M1	M0	Length	
			Sequential	Interleave
0	0	0	1	1
0	0	1	2	2
0	1	0	4	4
0	1	1	8	8
1	0	0	Reserved	Reserved
1	0	1	Reserved	Reserved
1	1	0	Reserved	Reserved
1	1	1	Full Page	Reserved

$\overline{CAS}$ Latency

M6	M5	M4	Latency
0	0	0	Reserved
0	0	1	Reserved
0	1	0	2
0	1	1	3
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

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Burst Mode Operation

Burst mode operation is used to provide a constant flow of data to memory locations (write cycle), or from memory locations (read cycle). Three parameters define how the burst mode will operate: burst sequence, burst length, and operation mode. The burst sequence and burst length are programmable and are determined by address bits A0 - A3 during the Mode Register Set command. Operation mode is also programmable and is set by address bits A7 - A13.

Burst sequence defines the order in which the burst data will be delivered or stored to the SDRAM. The two types of burst sequence supported are sequential and interleaved. See the table below.

The burst length controls the number of bits that will be output after a Read Command, or the number of bits to be input after a Write Command. The burst length can be programmed to have values of 1, 2, 4, 8 or full page (actual page length is dependent on organization: x4, x8, or x16). Full page burst operation is only possible using the sequential burst type.

Burst operation mode can be normal operation or multiple burst with single write operation. Normal operation implies that the device will perform burst operations on both read and write cycles until the desired burst length is satisfied. Multiple burst with single write operation was added to support Write Through Cache operation. Here, the programmed burst length only applies to read cycles. All write cycles are single write operations when this mode is selected.

Burst Length and Sequence

Burst Length	Starting Address (A2 A1 A0)	Sequential Addressing (decimal)	Interleave Addressing (decimal)
2	x x 0	0, 1	0, 1
	x x 1	1, 0	1, 0
4	x 0 0	0, 1, 2, 3	0, 1, 2, 3
	x 0 1	1, 2, 3, 0	1, 0, 3, 2
	x 1 0	2, 3, 0, 1	2, 3, 0, 1
	x 1 1	3, 0, 1, 2	3, 2, 1, 0
8	0 0 0	0, 1, 2, 3, 4, 5, 6, 7	0, 1, 2, 3, 4, 5, 6, 7
	0 0 1	1, 2, 3, 4, 5, 6, 7, 0	1, 0, 3, 2, 5, 4, 7, 6
	0 1 0	2, 3, 4, 5, 6, 7, 0, 1	2, 3, 0, 1, 6, 7, 4, 5
	0 1 1	3, 4, 5, 6, 7, 0, 1, 2	3, 2, 1, 0, 7, 6, 5, 4
	1 0 0	4, 5, 6, 7, 0, 1, 2, 3	4, 5, 6, 7, 0, 1, 2, 3
	1 0 1	5, 6, 7, 0, 1, 2, 3, 4	5, 4, 7, 6, 1, 0, 3, 2
	1 1 0	6, 7, 0, 1, 2, 3, 4, 5	6, 7, 4, 5, 2, 3, 0, 1
	1 1 1	7, 0, 1, 2, 3, 4, 5, 6	7, 6, 5, 4, 3, 2, 1, 0
Full Page (Note)	n n n	Cn, Cn+1, Cn+2, ...	Not Supported

Note: Page length is a function of I/O organization and column addressing.

x4 Organization (CA0-CA9); Page Length = 1024 bits

x8 Organization (CA0-CA8); Page Length = 512 bits

x16 Organization (CA0-CA7); Page Length = 256 bits

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Bank Activate Command

In relation to the operation of a fast page mode DRAM, the Bank Activate command corresponds to a falling $\overline{RAS}$ signal. The Bank Activate command is issued by holding $\overline{CAS}$ and $\overline{WE}$ high with $\overline{CS}$ and $\overline{RAS}$ low at the rising edge of the clock. The bank select address A12 - A13 is used to select the desired bank. The row address A0 - A11 is used to determine which row to activate in the selected bank. Activation of banks within both decks of a 2-high stacked device is allowed.

The Bank Activate command must be applied before any Read or Write operation can be executed. The delay from when the Bank Activate command is applied to when the first read or write operation can begin must meet or exceed the $\overline{RAS}$ to $\overline{CAS}$ delay time (t_{RCD}). Once a bank has been activated, it must be pre-charged before another Bank Activate command can be applied to the same bank. The minimum time interval between successive Bank Activate commands to the same bank is determined by the RAS cycle time of the device (t_{RC}). The minimum time interval between interleaved Bank Activate commands (Bank A to Bank B and vice versa) is the Bank to Bank delay time (t_{RRD}). The maximum time that each bank can be held active is specified as $t_{RAS(max)}$.

Bank Activate Command Cycle

$(\overline{CAS}$ Latency = 3 t_{RCD} = 3)
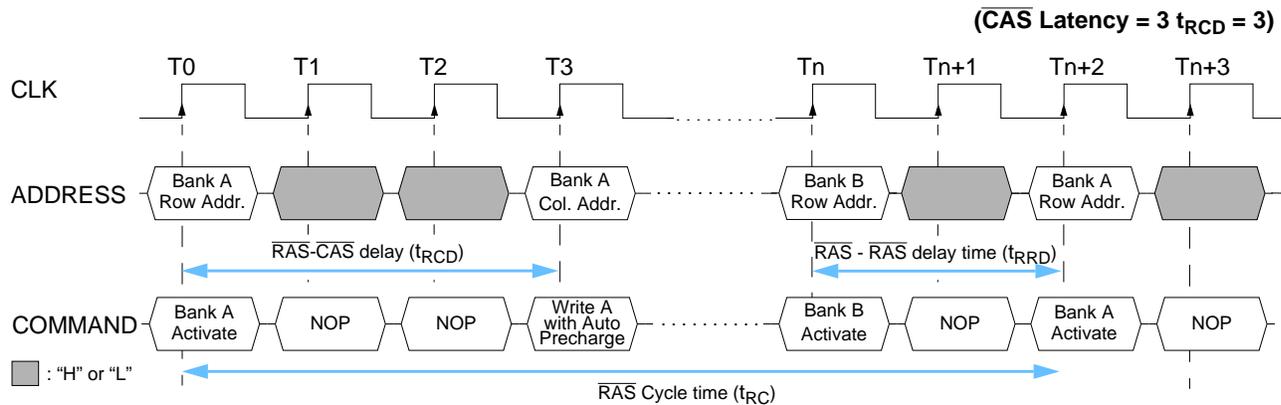
Bank Select

The Bank Select inputs, BS0 and BS1, determine the bank to be used during a Bank Activate, Precharge, Read, or Write operation.

Bank Selection Bits

BS0	BS1	Bank
0	0	Bank 0
0	1	Bank 1
1	0	Bank 2
1	1	Bank 3

Read and Write Access Modes

After a bank has been activated, a read or write cycle can be executed. This is accomplished by setting $\overline{RAS}$ high and $\overline{CAS}$ low at the clock's rising edge after the necessary $\overline{RAS}$ to $\overline{CAS}$ delay (t_{RCD}). $\overline{WE}$ must also be defined at this time to determine whether the access cycle is a read operation ($\overline{WE}$ high), or a write operation ($\overline{WE}$ low). The address inputs determine the starting column address.

The SDRAM provides a wide variety of fast access modes. A single Read or Write Command will initiate a serial read or write operation on successive clock cycles at data rates of up to 147 MHz. The number of serial data bits for each access is equal to the burst length, which is programmed into the Mode Register. If the burst length is full page, data is repeatedly read out or written until a Burst Stop or Precharge Command is issued.
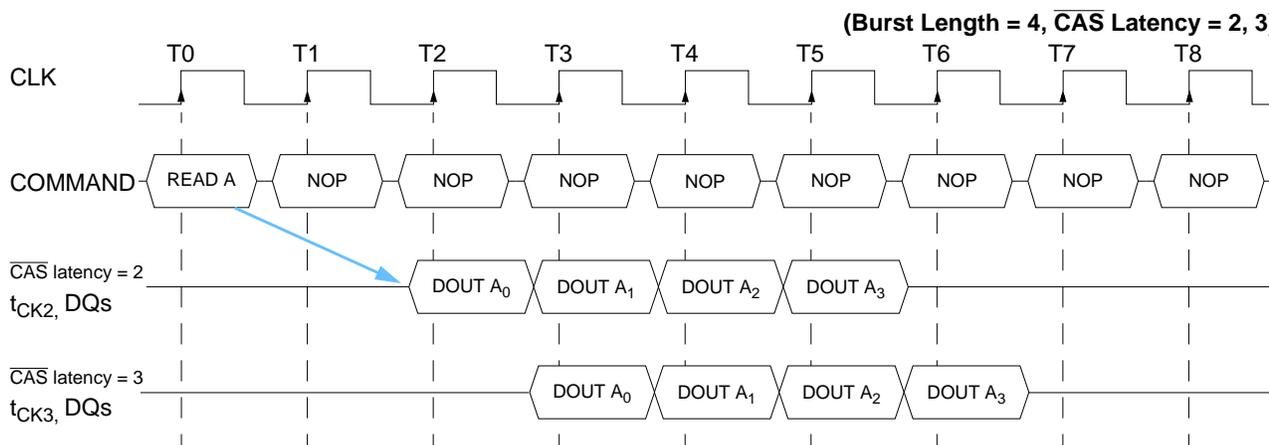
Similar to Page Mode of conventional DRAMs, a read or write cycle can not begin until the sense amplifiers latch the selected row address information. The refresh period (t_{REF}) is what limits the number of random column accesses to an activated bank. A new burst access can be done even before the previous burst ends. The ability to interrupt a burst operation at every clock cycle is supported; this is referred to as the 1-N rule. When the previous burst is interrupted by another Read or Write Command, the remaining addresses are overridden by the new address.

Precharging an active bank after each read or write operation is not necessary, providing the same row is to be accessed again. To perform a read or write cycle to a different row within an activated bank, the bank must be precharged and a new Bank Activate command must be issued. When more than one bank is activated, interleaved (ping pong) bank Read or Write operations are possible. By using the programmed burst length and alternating the access and precharge operations between multiple banks, fast and seamless data access operation among many different pages can be realized. When multiple banks are activated, column to column interleave operation can be done between different pages. Finally, Read or Write Commands can be issued to the same bank or between active banks on every clock cycle.

Burst Read Command

The Burst Read command is initiated by having $\overline{CS}$ and $\overline{CAS}$ low while holding $\overline{RAS}$ and $\overline{WE}$ high at the rising edge of the clock. The address inputs determine the starting column address for the burst. The Mode Register sets the type of burst (sequential or interleave) and the burst length (1, 2, 4, 8, full page). The delay from the start of the command to when the data from the first cell appears on the outputs is equal to the value of the $\overline{CAS}$ latency that is set in the Mode Register.

Burst Read Operation

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

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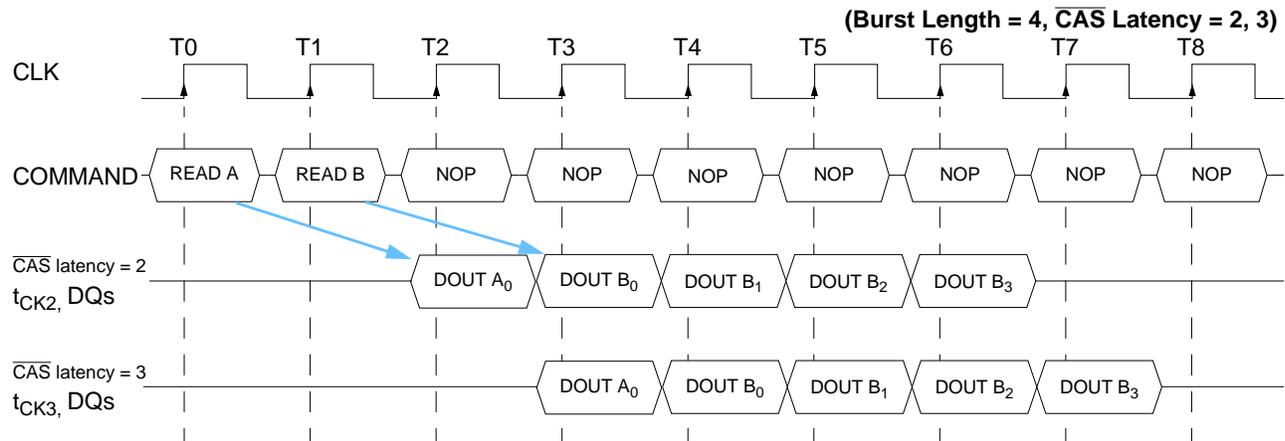**64Mb Synchronous DRAM - Die Revision B**

Read Interrupted by a Read

A Burst Read may be interrupted before completion of the burst by another Read Command, with the only restriction being that the interval that separates the commands must be at least one clock cycle. When the previous burst is interrupted, the remaining addresses are overridden by the new address with the full burst length. The data from the first Read Command continues to appear on the outputs until the $\overline{CAS}$ latency from the interrupting Read Command is satisfied, at this point the data from the interrupting Read Command appears.
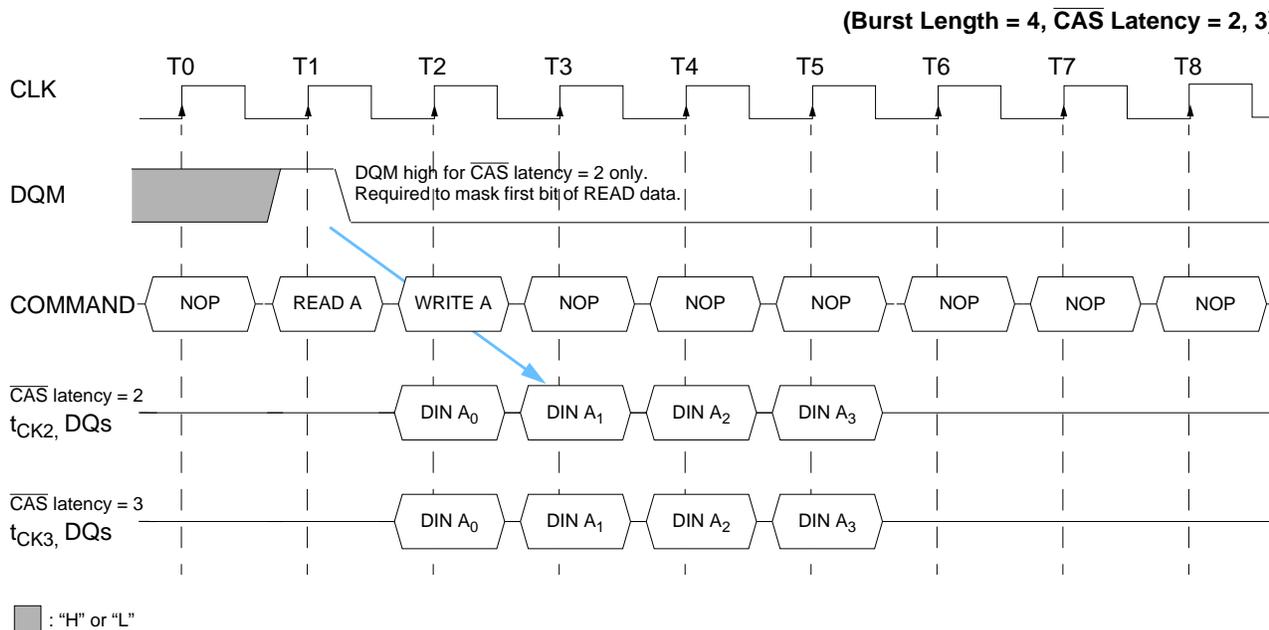
Read Interrupted by a Read

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

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Read Interrupted by a Write

To interrupt a burst read with a Write Command, DQM may be needed to place the DQs (output drivers) in a high impedance state to avoid data contention on the DQ bus. If a Read Command will issue data on the first and second clocks cycles of the write operation, DQM is needed to insure the DQs are tri-stated. After that point the Write Command will have control of the DQ bus.
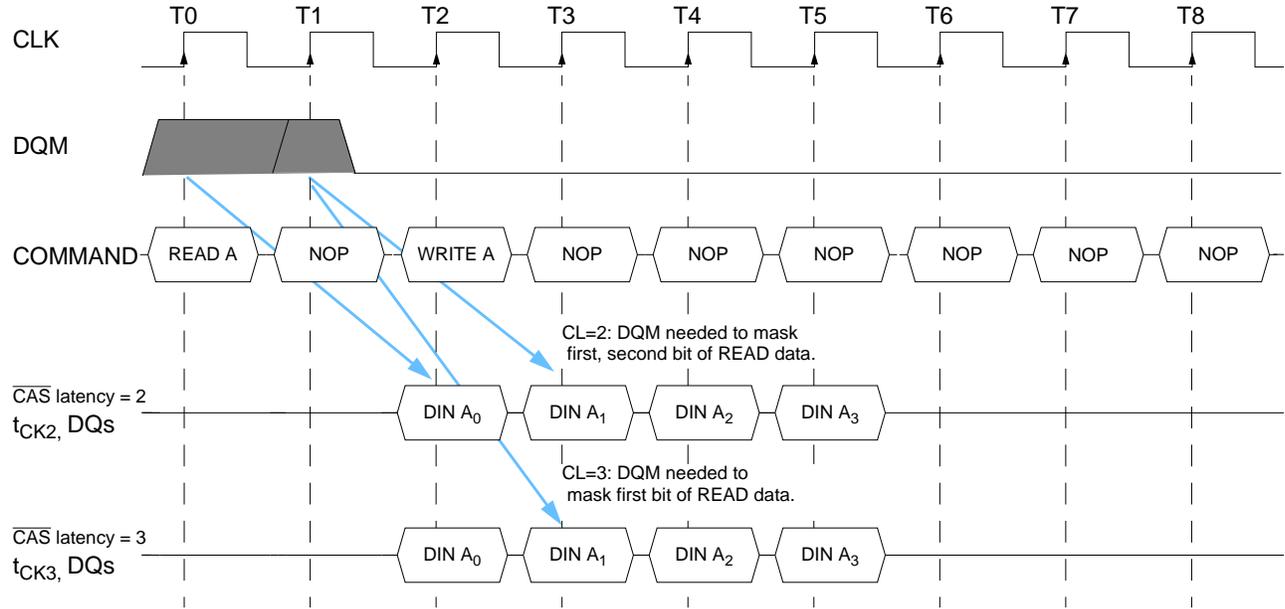
Minimum Read to Write Interval

(Burst Length = 4, $\overline{\text{CAS}}$ Latency = 2, 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8

CLK

DQM — DQM high for $\overline{\text{CAS}}$ latency = 2 only. Required to mask first bit of READ data.

COMMAND: NOP, READ A, WRITE A, NOP, NOP, NOP, NOP, NOP, NOP

$\overline{\text{CAS}}$ latency = 2
t_{CK2}, DQs: DIN A_0, DIN A_1, DIN A_2, DIN A_3

$\overline{\text{CAS}}$ latency = 3
t_{CK3}, DQs: DIN A_0, DIN A_1, DIN A_2, DIN A_3

▨ : "H" or "L"

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Non-Minimum Read to Write Interval

(Burst Length = 4, $\overline{\text{CAS}}$ Latency = 2, 3)

CL=2: DQM needed to mask
first, second bit of READ data.

CL=3: DQM needed to
mask first bit of READ data.

$\overline{\text{CAS}}$ latency = 2
t_{CK2}, DQs

$\overline{\text{CAS}}$ latency = 3
t_{CK3}, DQs

: DQM high for $\overline{\text{CAS}}$ latency = 2

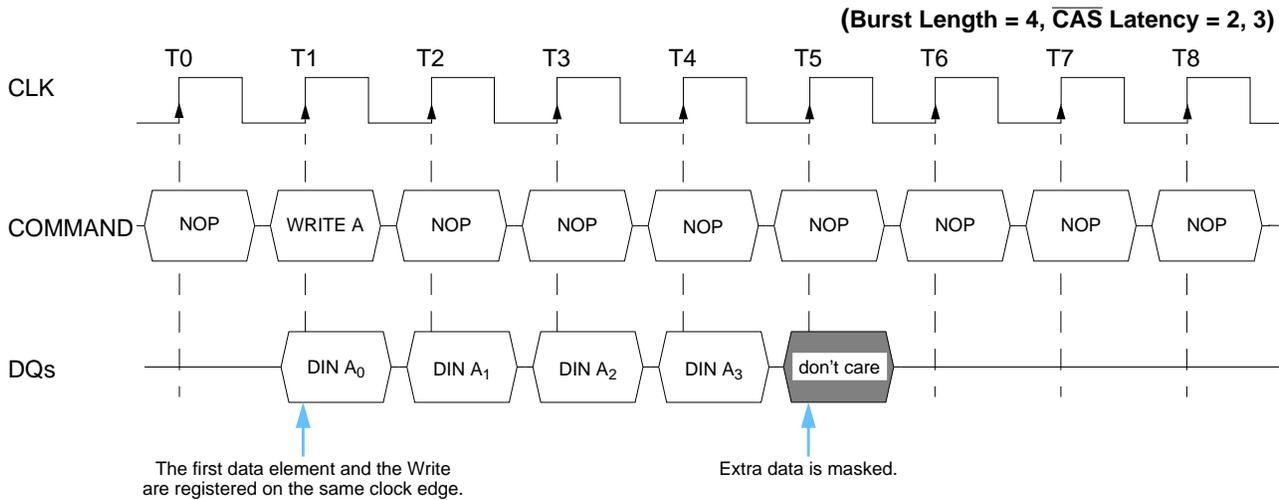: DQM high for $\overline{\text{CAS}}$ latency = 3

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Burst Write Command

The Burst Write command is initiated by having $\overline{CS}$, $\overline{CAS}$, and $\overline{WE}$ low while holding $\overline{RAS}$ high at the rising edge of the clock. The address inputs determine the starting column address. There is no $\overline{CAS}$ latency required for burst write cycles. Data for the first burst write cycle must be applied on the DQ pins on the same clock cycle that the Write Command is issued. The remaining data inputs must be supplied on each subsequent rising clock edge until the burst length is completed. When the burst has finished, any additional data supplied to the DQ pins will be ignored.
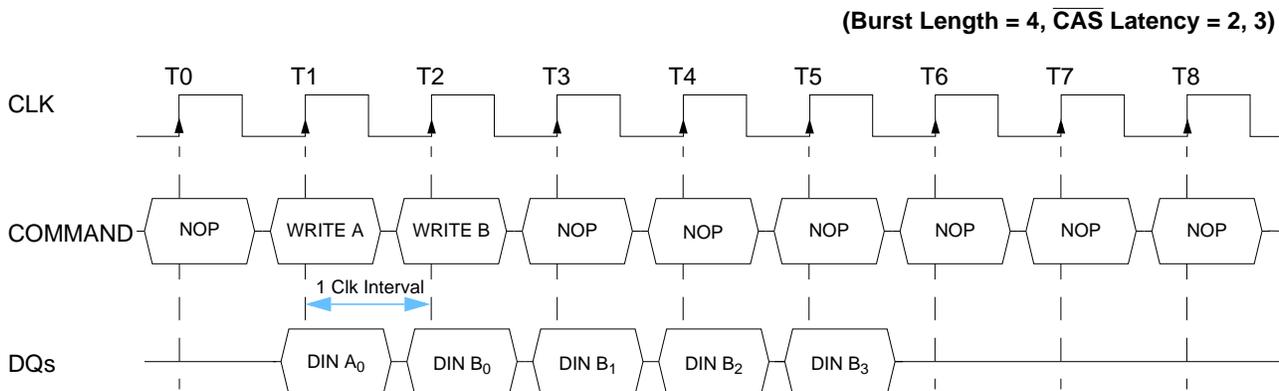
Burst Write Operation

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

The first data element and the Write are registered on the same clock edge.

Extra data is masked.

Write Interrupted by a Write

A burst write may be interrupted before completion of the burst by another Write Command. When the previous burst is interrupted, the remaining addresses are overridden by the new address and data will be written into the device until the programmed burst length is satisfied.

Write Interrupted by a Write

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

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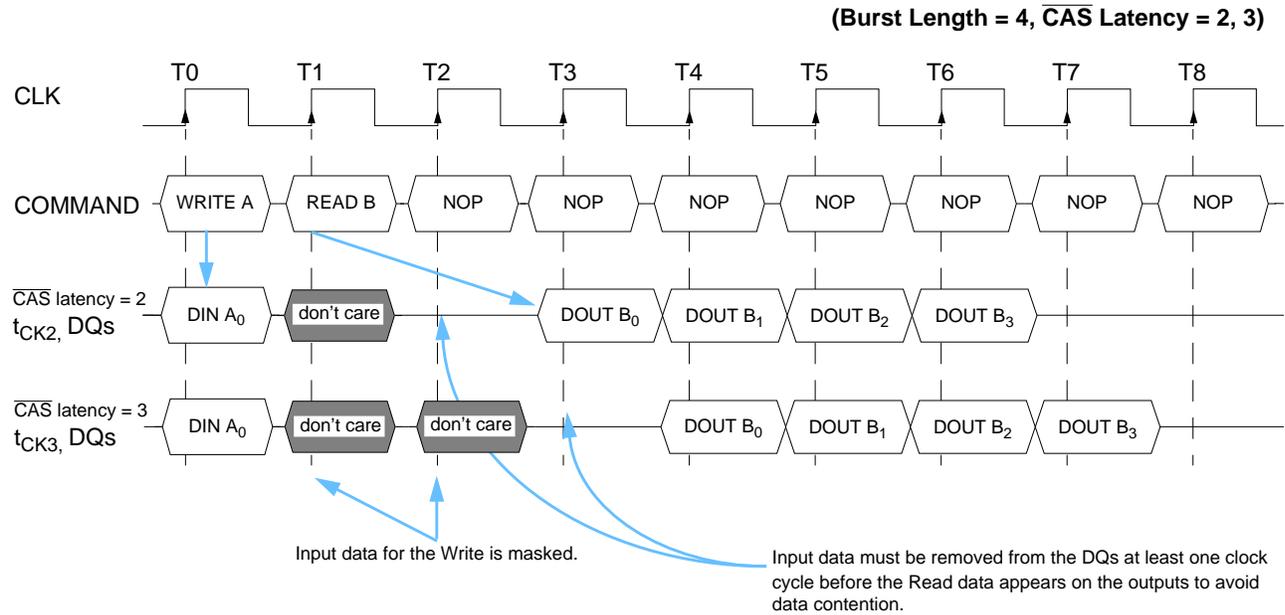**64Mb Synchronous DRAM - Die Revision B**

Write Interrupted by a Read

A Read Command will interrupt a burst write operation on the same clock cycle that the Read Command is registered. The DQs must be in the high impedance state at least one cycle before the interrupting read data appears on the outputs to avoid data contention. When the Read Command is registered, any residual data from the burst write cycle will be ignored. Data that is presented on the DQ pins before the Read Command is initiated will actually be written to the memory.
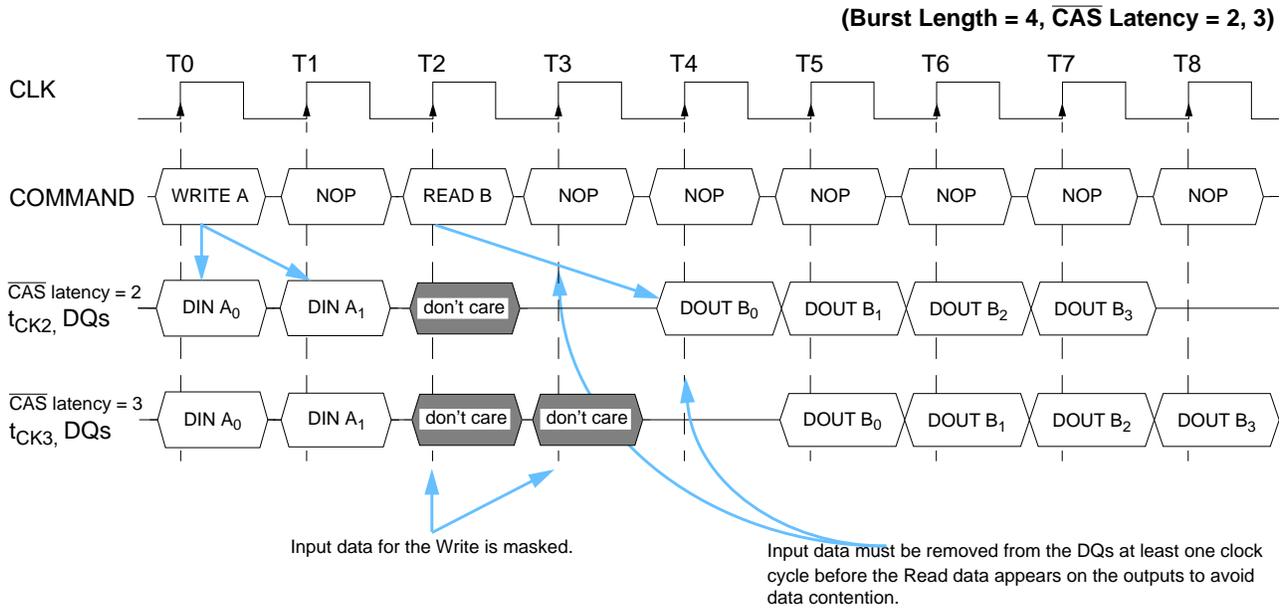
Minimum Write to Read Interval

(Burst Length = 4, $\overline{\text{CAS}}$ Latency = 2, 3)

Input data for the Write is masked.

Input data must be removed from the DQs at least one clock cycle before the Read data appears on the outputs to avoid data contention.

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Non-Minimum Write to Read Interval

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

Input data for the Write is masked.

Input data must be removed from the DQs at least one clock cycle before the Read data appears on the outputs to avoid data contention.

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Burst Stop Command

Once a burst read or write operation has been initiated, there exist several methods in which to terminate the burst operation prematurely. These methods include using another Read or Write Command to interrupt an existing burst operation or using a Precharge Command to interrupt a burst cycle and close the active bank. When interrupting a burst with another Read or Write Command care must be taken to avoid DQ contention.

If the burst length is full page, the Burst Stop Command may also be used to terminate the existing burst operation but leave the bank open for future Read or Write Commands to the same page of the active bank. Use of the Burst Stop Command during other burst length operations is illegal. The Burst Stop Command is defined by having $\overline{RAS}$ and $\overline{CAS}$ high with $\overline{CS}$ and $\overline{WE}$ low at the rising edge of the clock.

When using the Burst Stop Command during a burst read cycle, the data DQs go to a high impedance state after a delay which is equal to the $\overline{CAS}$ Latency set in the Mode Register.

Termination of a Burst Read Operation

(Burst Length = Full Page, $\overline{CAS}$ Latency = 2, 3)
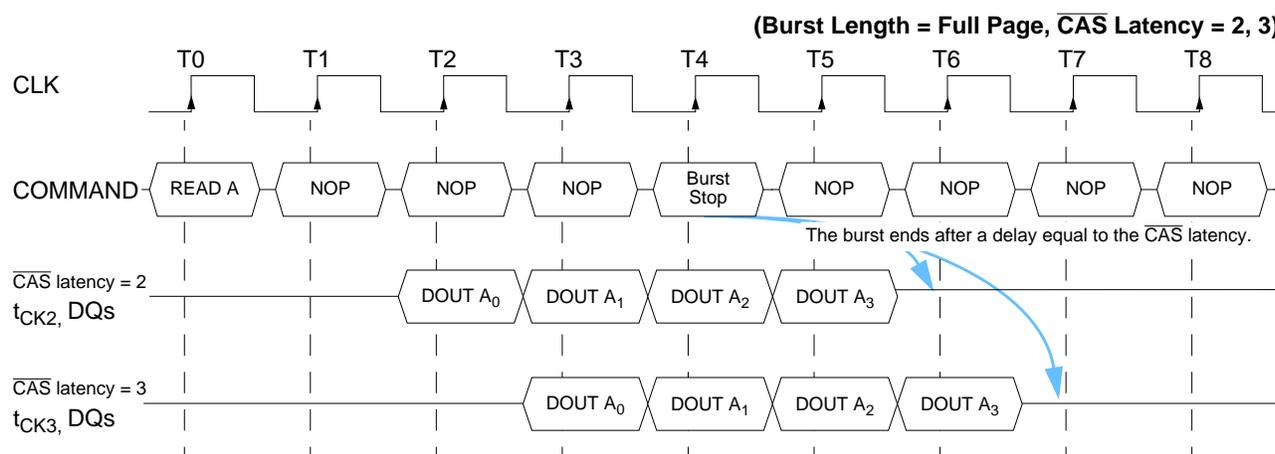
If a Burst Stop Command is issued during a full page burst write operation, then any residual data from the burst write cycle will be ignored. Data that is presented on the DQ pins before the Burst Stop Command is registered will be written to the memory.

Termination of a Burst Write Operation
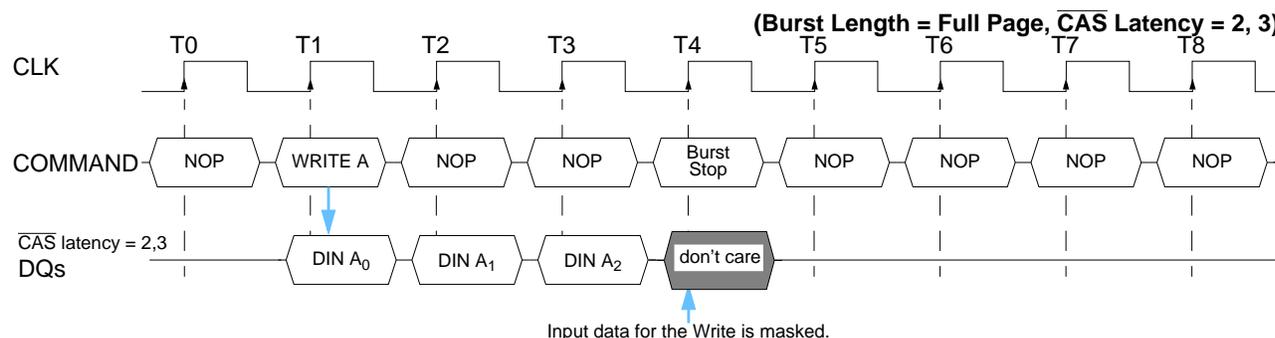
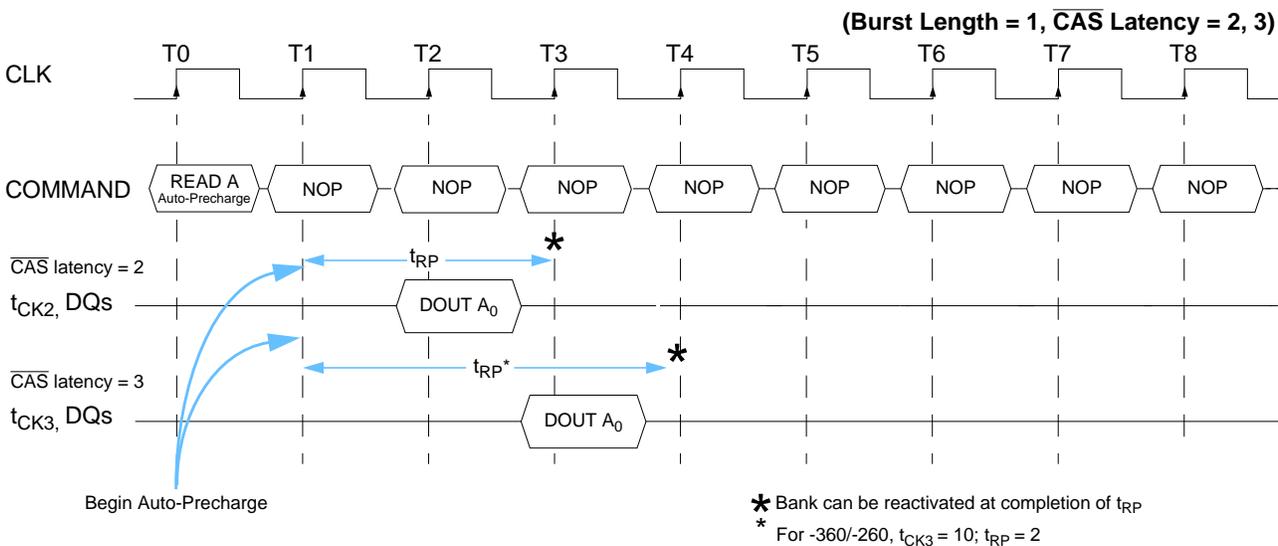(Burst Length = Full Page, $\overline{CAS}$ Latency = 2, 3)

Auto-Precharge Operation

Before a new row in an active bank can be opened, the active bank must be precharged using either the Pre-charge Command or the auto-precharge function. When a Read or a Write Command is given to the SDRAM, the $\overline{CAS}$ timing accepts one extra address, column address A10, to allow the active bank to automatically begin precharge at the earliest possible moment during the burst read or write cycle. If A10 is low when the Read or Write Command is issued, then normal Read or Write burst operation is executed and the bank remains active at the completion of the burst sequence. If A10 is high when the Read or Write Command is issued, then the auto-precharge function is engaged. During auto-precharge, a Read Command will execute as normal with the exception that the active bank will begin to precharge before all burst read cycles have been completed. Regardless of burst length, the precharge will begin ($\overline{CAS}$ latency - 1) clocks prior to the last data output. Auto-precharge can also be implemented during Write commands.

A Read or Write Command without auto-precharge can be terminated in the midst of a burst operation. However, a Read or Write Command with auto-precharge can not be interrupted by a command to the same bank. Therefore use of a Read, Write, or Precharge Command to the same bank is prohibited during a read or write cycle with auto-precharge until the entire burst operation is completed. Once the precharge operation has started the bank cannot be reactivated until the Precharge time (t_{RP}) has been satisfied. It should be noted that the device will not respond to the Auto-Precharge command if the device is programmed for full page burst read or write cycles, or full page burst read cycles with single write operation.

When using the Auto-Precharge Command, the interval between the Bank Activate Command and the beginning of the internal precharge operation must satisfy $t_{RAS(min)}$. If this interval does not satisfy $t_{RAS(min)}$ then t_{RCD} must be extended.

Burst Read with Auto-Precharge

(Burst Length = 1, $\overline{CAS}$ Latency = 2, 3)

✱ Bank can be reactivated at completion of t_{RP}
* For -360/-260, $t_{CK3} = 10$; $t_{RP} = 2$

Burst Read with Auto-Precharge

(Burst Length = 2, $\overline{CAS}$ Latency = 2, 3)

$\overline{CAS}$ latency = 2
t_{CK2}, DQs

$\overline{CAS}$ latency = 3
t_{CK3}, DQs

Begin Auto-Precharge

✱ Bank can be reactivated at completion of t_{RP}
* For -360/-260, t_{CK3} = 10; t_{RP} = 2

Burst Read with Auto-Precharge

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

$\overline{CAS}$ latency = 2
t_{CK2}, DQs

$\overline{CAS}$ latency = 3
t_{CK3}, DQs

Begin Auto-Precharge

✱ Bank can be reactivated at completion of t_{RP}
* For -360/-260, t_{CK3} = 10: t_{RP} = 2
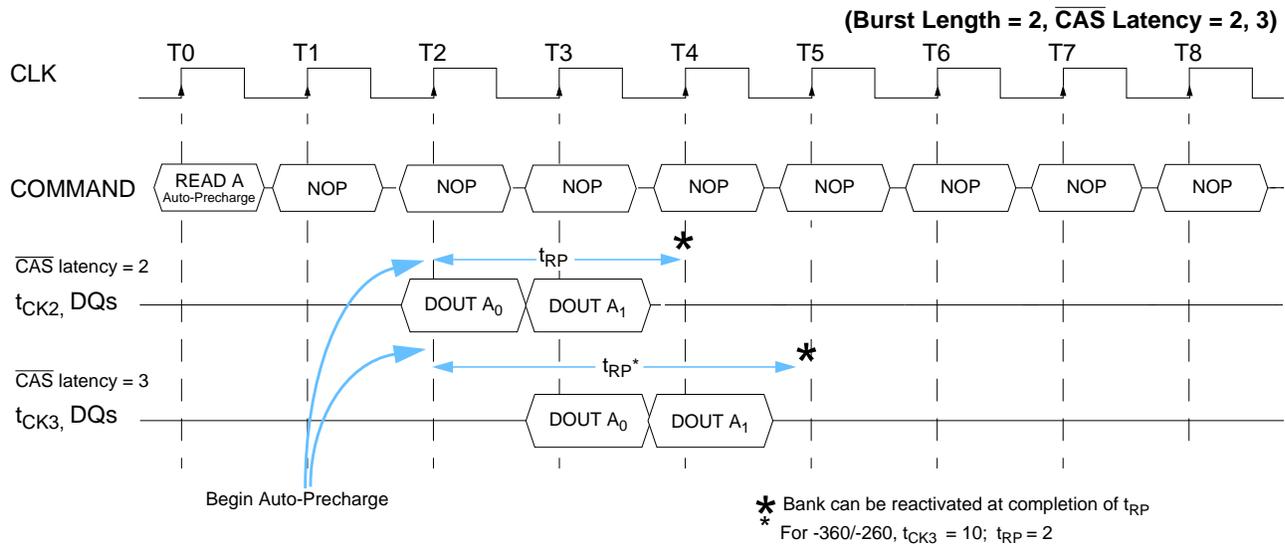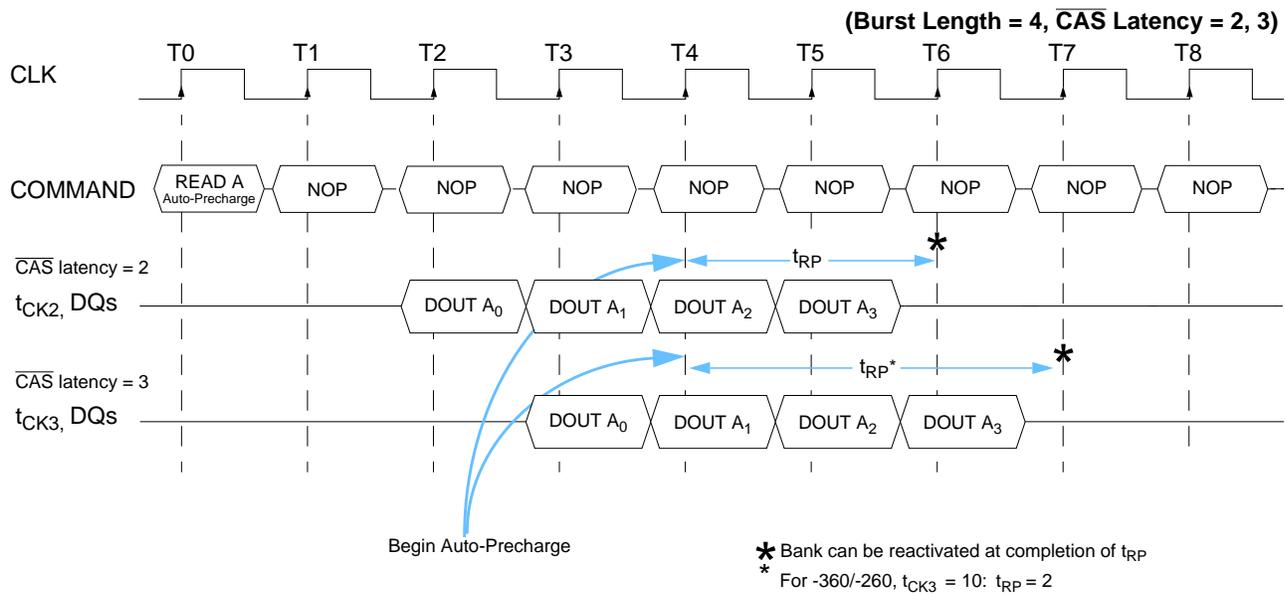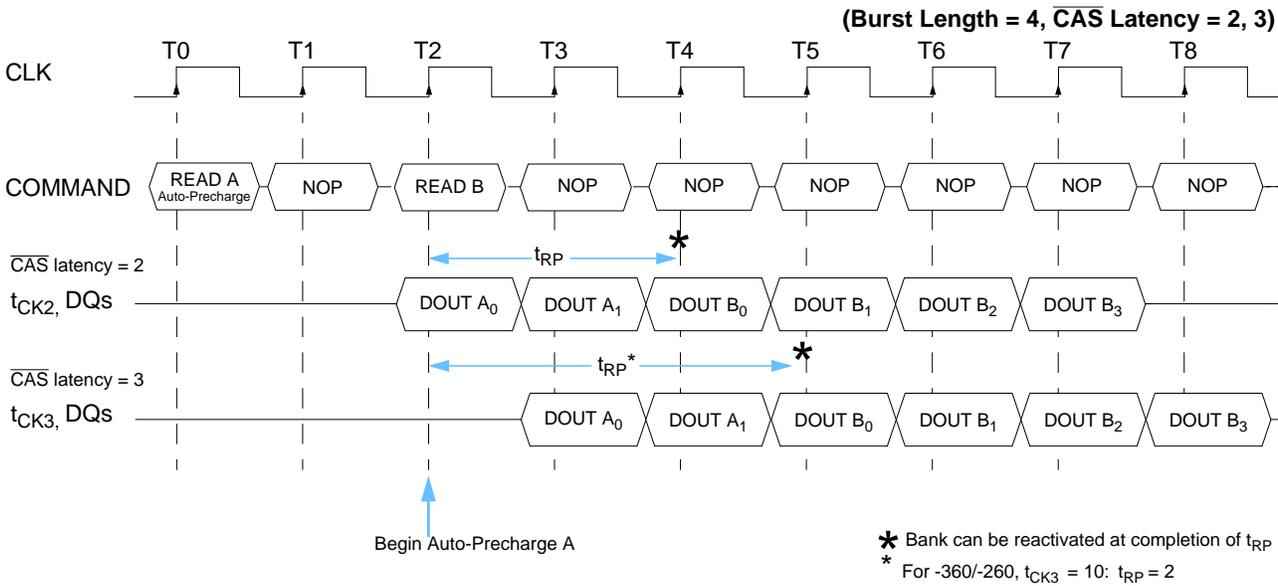
Although a Read Command with auto-precharge cannot be interrupted by a command to the same bank, it can be interrupted by a Read or Write Command to a different bank. If the interrupting command is issued before auto-precharge begins then the precharge function will begin with the new command. The bank being auto-precharged may be reactivated after the delay t_{RP}.

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Burst Read with Auto-Precharge Interrupted by Read

(Burst Length = 4, $\overline{CAS}$ Latency = 2, 3)

Begin Auto-Precharge A

$*$ Bank can be reactivated at completion of t_{RP}
$**$ For -360/-260, t_{CK3} = 10: t_{RP} = 2

If interrupting a Read Command with auto-precharge with a Write Command, DQM must be used to avoid DQ contention.

Burst Read with Auto-Precharge Interrupted by Write

(Burst Length = 8, $\overline{CAS}$ Latency = 2)

Begin Auto-Precharge A

$*$ Bank A can be reactivated at completion of t_{RP}

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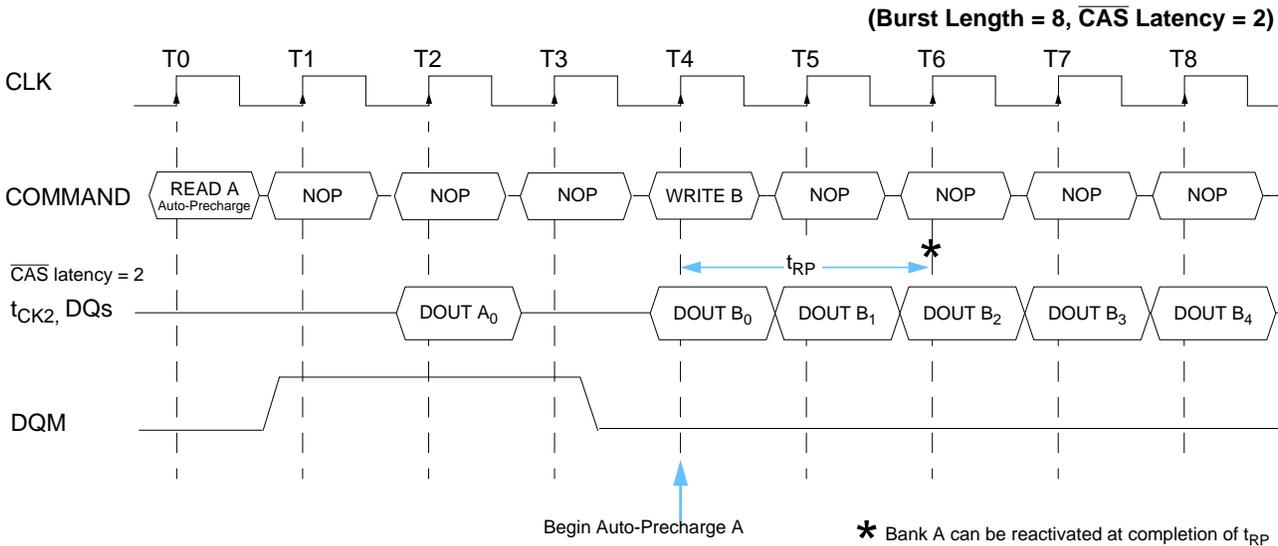
If A10 is high when a Write Command is issued, the Write with Auto-Precharge function is initiated. The SDRAM automatically enters the precharge operation after a delay from the last burst write cycle referred to as Data-in to Precharge delay, t_{DPL}. The bank undergoing auto-precharge can not be reactivated until t_{DPL} and t_{RP} are satisfied. This is referred to as t_{DAL}, Data-in to Active delay ($t_{DAL} = t_{DPL} + t_{RP}$).

Burst Write with Auto-Precharge

(Burst Length = 2, $\overline{CAS}$ Latency = 2, 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8

CLK

COMMAND: BANK A ACTIVE — NOP — NOP — WRITE A Auto-Precharge — NOP — NOP — NOP — NOP — NOP

$\overline{CAS}$ latency = 2
t_{CK2}, DQs: DIN A_0 — DIN A_1 ; t_{DPL} ; t_{RP} ; *

$\overline{CAS}$ latency = 3
t_{CK3}, DQs: DIN A_0 — DIN A_1 ; t_{DPL} ; t_{RP}* ; *

* For -360/-260, t_{CK3} = 10; t_{RP} = 2

Begin Auto-Precharge

*Bank can be reactivated at completion of t_{RP}

Similar to the Read Command, a Write Command with auto-precharge can not be interrupted by a command to the same bank. It can be interrupted by a Read or Write Command to a different bank, however. The precharge function will begin with the new command. The bank may be reactivated after t_{RP} is satisfied.

Burst Write with Auto-Precharge Interrupted by Write

(Burst Length = 4, $\overline{CAS}$ Latency = 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8

CLK

COMMAND: BANK A ACTIVE — NOP — NOP — WRITE A Auto-Precharge — NOP — WRITE B — NOP — NOP — NOP

$\overline{CAS}$ latency = 3
t_{CK3}, DQs: t_{RCD}* ; DIN A_0 — DIN A_1 — DIN B_0 — DIN B_1 — DIN B_2 — DIN B_3 ; t_{RP}* ; *

* For -360/-260, t_{CK3} = 10: t_{RP}, t_{RCD} = 2

Begin Auto-Precharge A

*Bank A can be reactivated at completion of t_{RP}
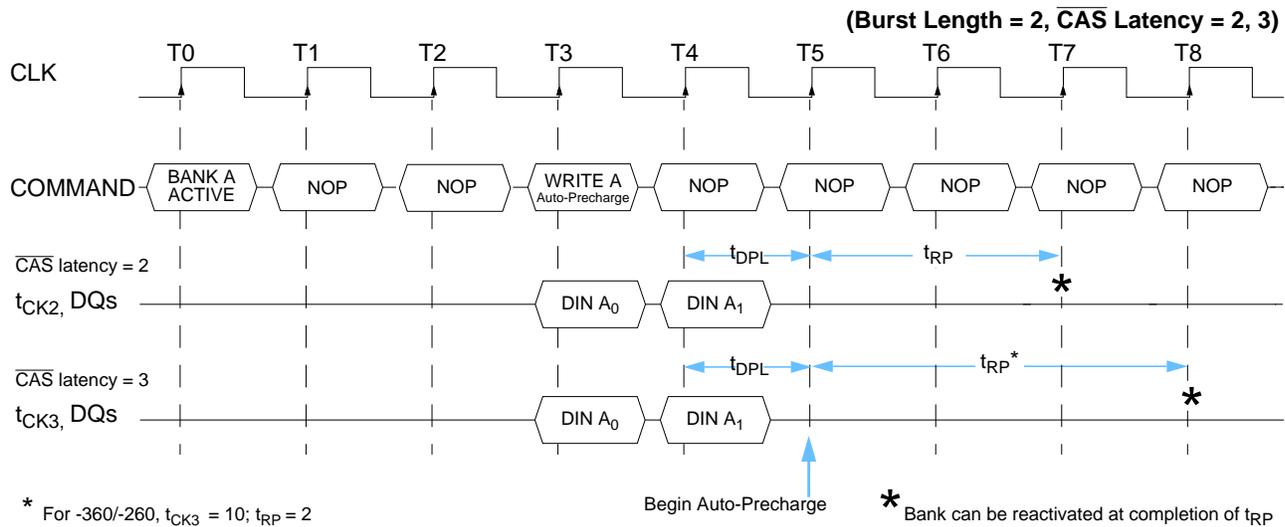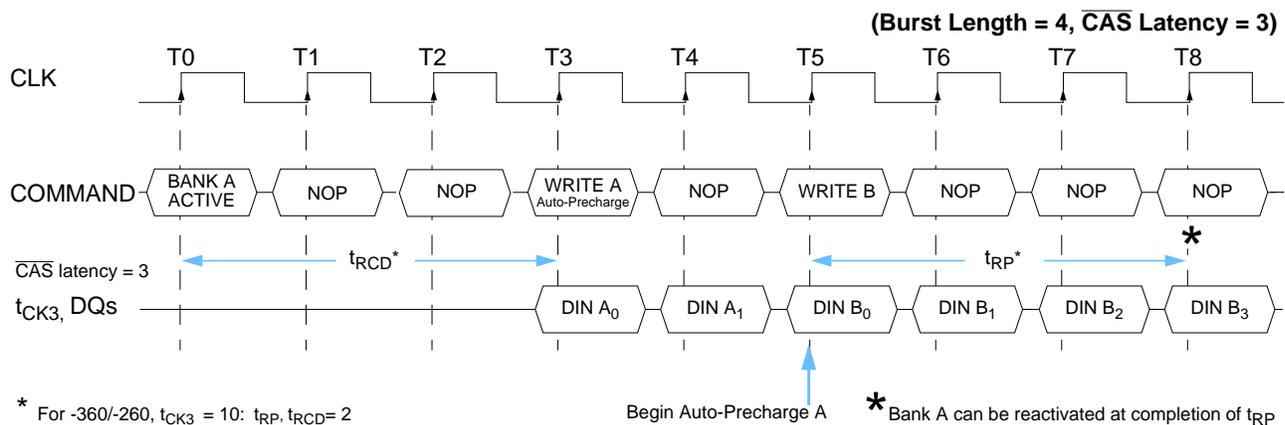
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Burst Write with Auto-Precharge Interrupted by Read

(Burst Length = 4, $\overline{CAS}$ Latency = 3)

* For -360/-260, t_{CK3} = 10; t_{RP} = 2
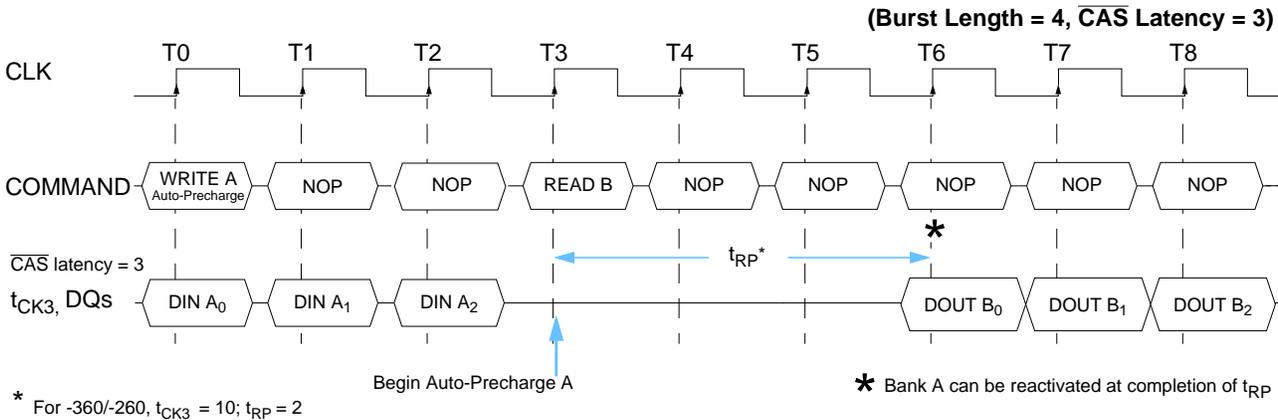
Precharge Command

The Precharge Command is used to precharge or close a bank that has been activated. The Precharge Command is triggered when $\overline{CS}$, $\overline{RAS}$, and $\overline{WE}$ are low and $\overline{CAS}$ is high at the rising edge of the clock. The Precharge Command can be used to precharge each bank separately or all banks simultaneously. Three address bits—A10, A12, and A13—are used to define which bank(s) is to be precharged when the command is issued.

Bank Selection for Precharge by Address Bits

| A10	Bank Select	Precharged Bank(s)
LOW	BS0, BS1	Bank defined by BS0, BS1 only
HIGH	DON'T CARE	All Banks

For read cycles, the Precharge Command may be applied ($\overline{CAS}$ latency - 1) clocks prior to the last data output. For write cycles, a delay must be satisfied from the start of the last burst write cycle until the Precharge Command can be issued. This delay is known as t_{DPL}, Data-in to Precharge delay.

After the Precharge Command is issued, the precharged bank must be reactivated before a new read or write access can be executed. The delay between the Precharge Command and the Activate Command must be greater than or equal to the Precharge time (t_{RP}).

Burst Read followed by the Precharge Command

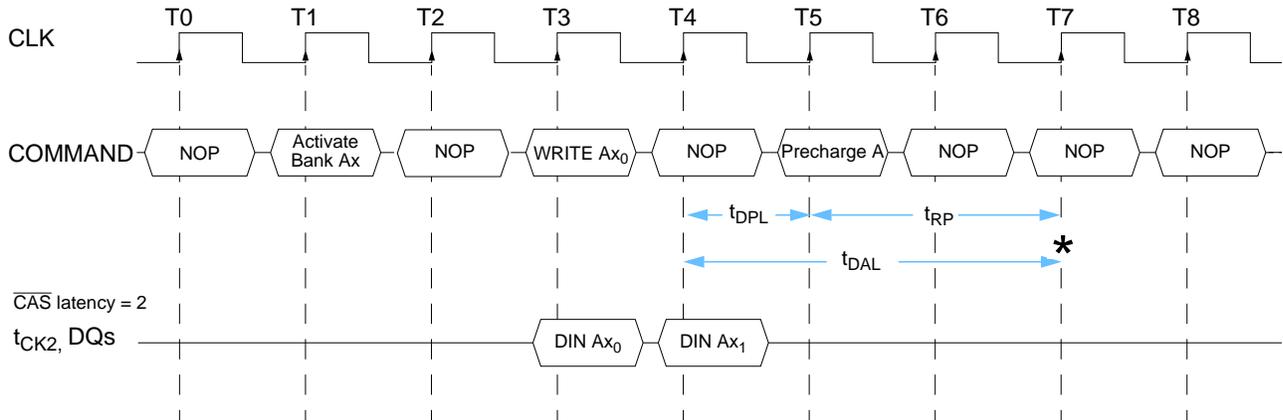**(Burst Length = 4, $\overline{CAS}$ Latency = 2)**
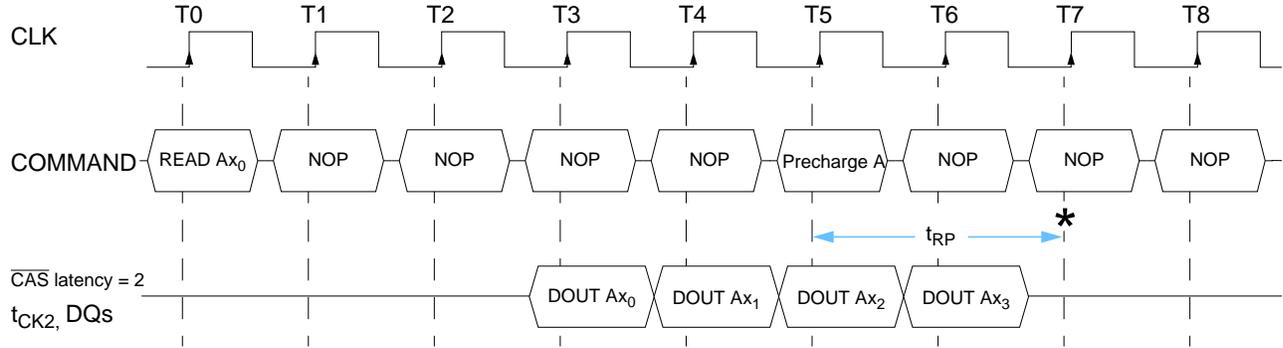
$\star$ Bank A can be reactivated at completion of t_{RP}

Burst Write followed by the Precharge Command

(Burst Length = 2, CAS Latency = 2)

$\star$ Bank can be reactivated at completion of t_{DAL}

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Precharge Termination

The Precharge Command may be used to terminate either a burst read or burst write operation. When the Precharge command is issued, the burst operation is terminated and bank precharge begins. For burst read operations, valid data will continue to appear on the data bus as a function of $\overline{CAS}$ Latency.

Burst Read Interrupted by Precharge

(Burst Length = 8, $\overline{CAS}$ Latency = 2, 3)
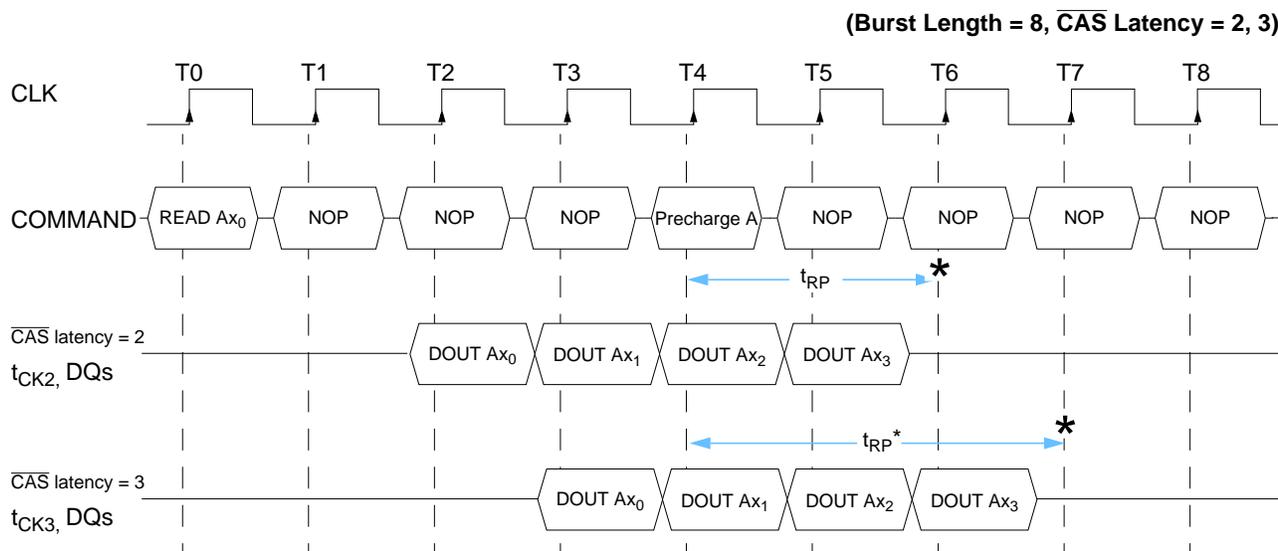
*For -360/-260, t_{CK3} = 10; t_{RP} = 2

✱ Bank A can be reactivated at completion of t_{RP}

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Burst write operations will be terminated by the Precharge command. The last write data that will be properly stored in the device is that write data that is presented to the device a number of clock cycles prior to the Precharge command equal to the Data-in to Precharge delay, t_{DPL}.

Precharge Termination of a Burst Write

(Burst Length = 8, CAS Latency =2, 3)
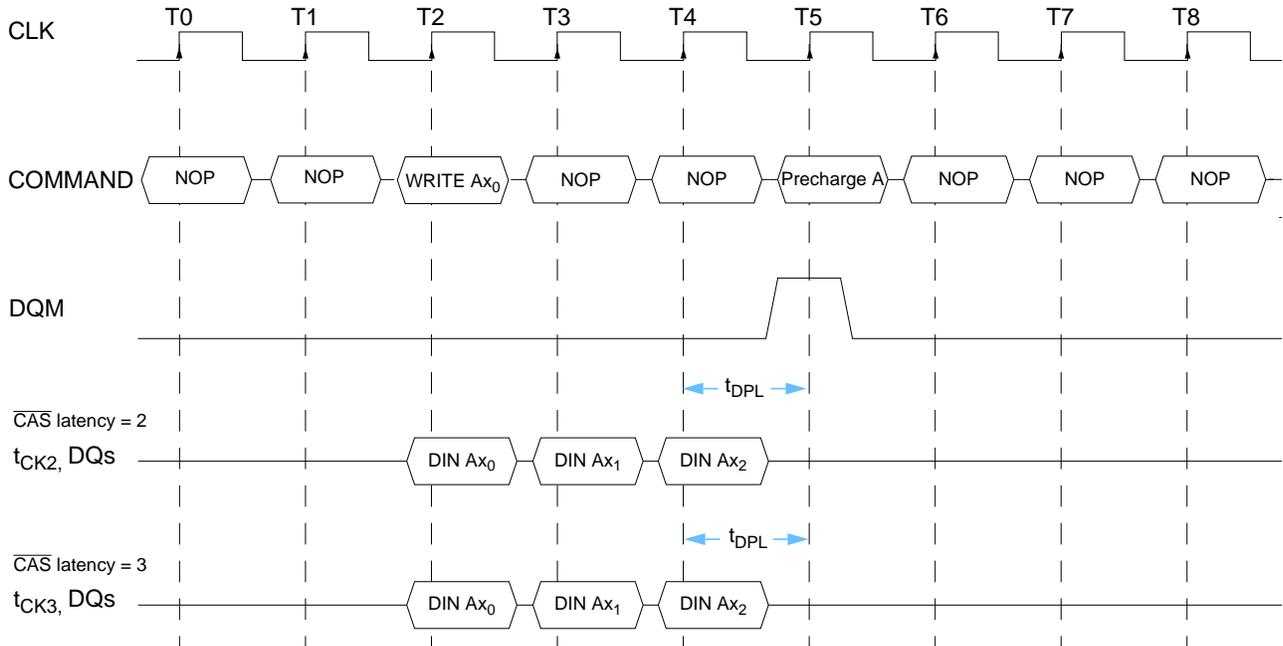
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Automatic Refresh Command ($\overline{CAS}$ before $\overline{RAS}$ Refresh)

When $\overline{CS}$, $\overline{RAS}$, and $\overline{CAS}$ are held low with CKE and $\overline{WE}$ high at the rising edge of the clock, the chip enters the Automatic Refresh mode (CBR). All banks of the SDRAM must be precharged and idle for a minimum of the Precharge time (t_{RP}) before the Auto Refresh Command (CBR) can be applied. For a stacked device, both decks may be refreshed at the same time using Automatic Refresh Mode. An address counter, internal to the device provides the address during the refresh cycle. No control of the external address pins is required once this cycle has started.

When the refresh cycle has completed, all banks of the SDRAM will be in the precharged (idle) state. A delay between the Auto Refresh Command (CBR) and the next Activate Command or subsequent Auto Refresh Command must be greater than or equal to the $\overline{RAS}$ cycle time (t_{RC}).

Self Refresh Command

The SDRAM device has a built-in timer to accommodate Self Refresh operation. The Self Refresh Command is defined by having $\overline{CS}$, $\overline{RAS}$, $\overline{CAS}$, and CKE held low with $\overline{WE}$ high at the rising edge of the clock. All banks must be idle prior to issuing the Self Refresh Command. Once the command is registered, CKE must be held low to keep the device in Self Refresh mode. When the SDRAM has entered Self Refresh mode all of the external control signals, except CKE, are disabled. The clock is internally disabled during Self Refresh Operation to save power. The user may halt the external clock while the device is in Self Refresh mode, however, the clock must be restarted before the device can exit Self Refresh operation. Once the clock is cycling, the device will exit Self Refresh operation after CKE is returned high. A minimum delay time is required when the device exits Self Refresh Operation and before the next command can be issued. This delay is equal to the $\overline{RAS}$ cycle time (t_{RC}) plus the Self Refresh exit time (t_{SREX}). When using Self Refresh, both decks of a stacked device may be refreshed at the same time.

Power Down Mode

In order to reduce standby power consumption, two power down modes are available: Precharge and Active Power Down mode. To enter Precharge Power Down mode, all banks must be precharged and the necessary precharge delay (t_{RP}) must occur before the SDRAM can enter the power down mode. If a bank is activated but not performing a Read or Write operation, Active Power Down mode will be entered. (Issuing a Power Down Mode Command when the device is performing a Read or Write operation causes the device to enter Clock Suspend mode. See the following section.) Once the Power Down mode is initiated by holding CKE low, all of the receiver circuits except CKE are gated off. The Power Down mode does not perform any refresh operations, therefore the device can't remain in Power Down mode longer than the Refresh period (t_{REF}) of the device.

The Power Down mode is exited by bringing CKE high. When CKE goes high, a No Operation Command (or a Device Deselect Command) is required on the next rising clock edge.

Power Down Mode Exit Timing
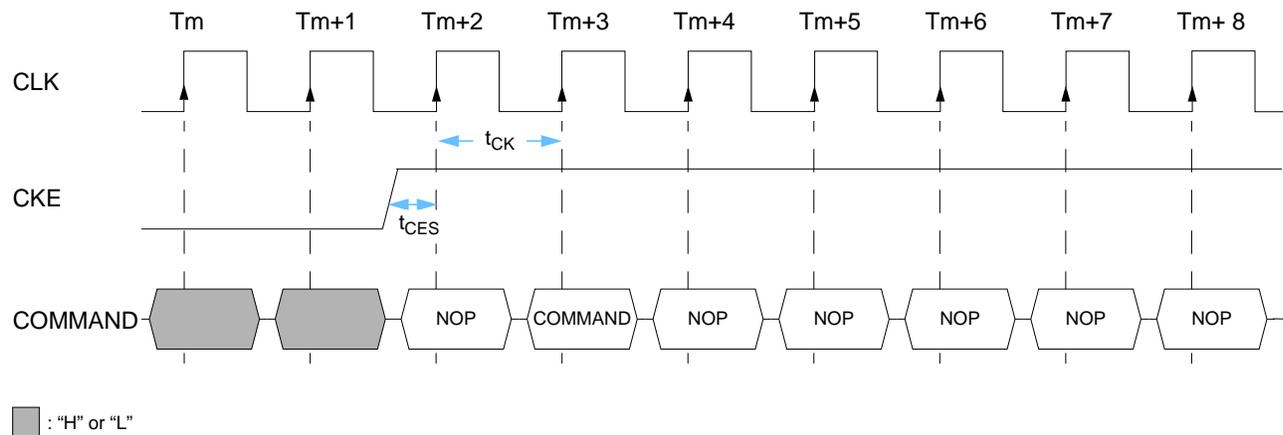
: "H" or "L"

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Data Mask

The SDRAM has a Data Mask function that can be used in conjunction with data read and write cycles. When the Data Mask is activated (DQM high) during a write cycle, the write operation is prohibited immediately (zero clock latency). If the Data Mask is activated during a read cycle, the data outputs are disabled and become high impedance after a two clock delay, independent of $\overline{CAS}$ latency.

Data Mask Activated During a Read Cycle

(Burst Length = 4, $\overline{CAS}$ Latency = 2)

: "H" or "L"
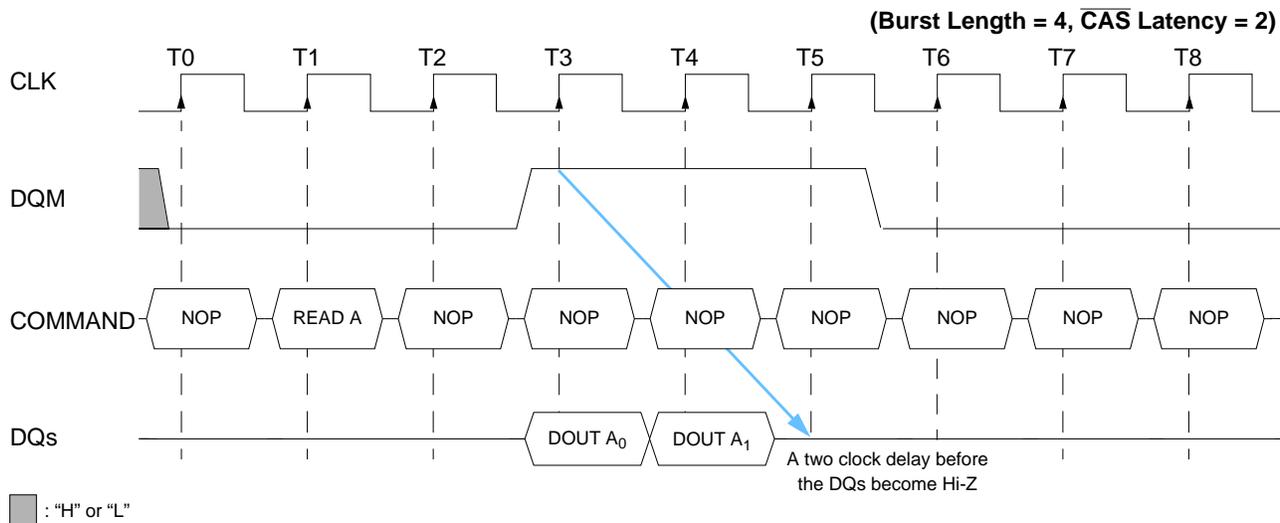
No Operation Command

The No Operation Command should be used in cases when the SDRAM is in a idle or a wait state. The purpose of the No Operation Command is to prevent the SDRAM from registering any unwanted commands between operations. A No Operation Command is registered when $\overline{CS}$ is low with $\overline{RAS}$, $\overline{CAS}$, and $\overline{WE}$ held high at the rising edge of the clock. A No Operation Command will not terminate a previous operation that is still executing, such as a burst read or write cycle.

Deselect Command

The Deselect Command performs the same function as a No Operation Command. Deselect Command occurs when $\overline{CS}$ is brought high, the $\overline{RAS}$, $\overline{CAS}$, and $\overline{WE}$ signals become don't cares.

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Clock Suspend Mode

During normal access mode, CKE is held high enabling the clock. When CKE is registered low while at least one of the banks is active, Clock Suspend Mode is entered. The Clock Suspend mode deactivates the internal clock and suspends or "freezes" any clocked operation that was currently being executed. There is a one clock delay between the registration of CKE low and the time at which the SDRAM's operation suspends. While in Clock Suspend mode, the SDRAM ignores any new commands that are issued. The Clock Suspend mode is exited by bringing CKE high. There is a one clock cycle delay from when CKE returns high to when Clock Suspend mode is exited.

When the operation of the SDRAM is suspended during the execution of a Burst Read operation, the last valid data output onto the DQ pins will be actively held valid until Clock Suspend mode is exited.

Clock Suspend During a Read Cycle

(Burst Length = 4, $\overline{CAS}$ Latency = 2)

: "H" or "L"
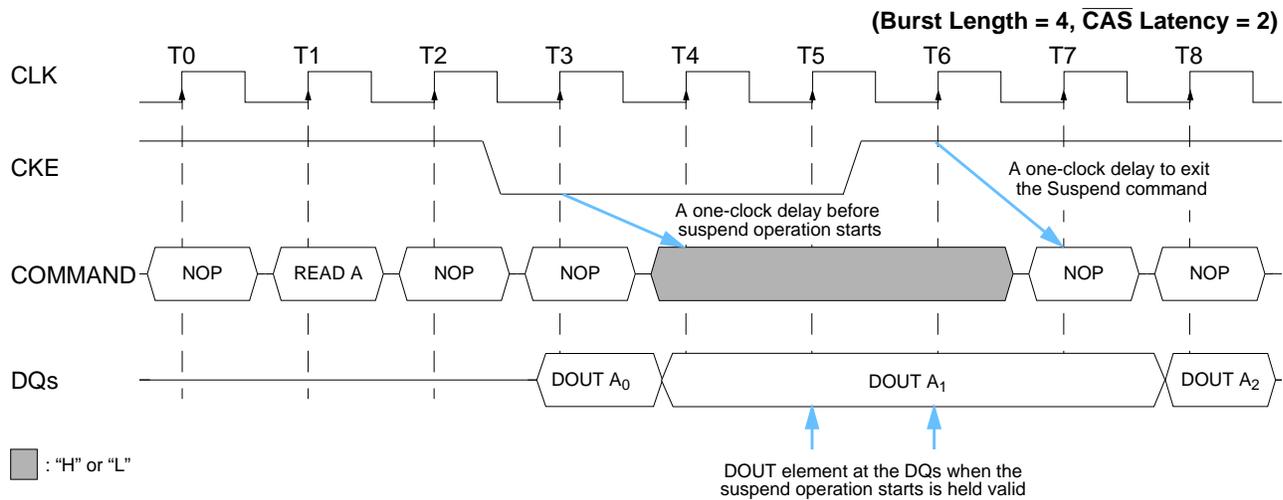
If Clock Suspend mode is initiated during a burst write operation, then the input data is masked and ignored until the Clock Suspend mode is exited.

Clock Suspend During a Write Cycle

(Burst Length = 4, $\overline{CAS}$ Latency = 2)

: "H" or "L"

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Command Truth Table (See note 1)

Function	Device State	CKE Previous Cycle	CKE Current Cycle	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	DQM	A12, A13	A10	A11, A9-A0	Notes
Mode Register Set	Idle	H	X	L	L	L	L	X	OP Code			
Auto (CBR) Refresh	Idle	H	H	L	L	L	H	X	X	X	X	
Entry Self Refresh	Idle	H	L	L	L	L	H	X	X	X	X	
Exit Self Refresh	Idle (Self-Refresh)	L	H	H	X	X	X	X	X	X	X	
				L	H	H	H					
Single Bank Precharge	See Current State Table	H	X	L	L	H	L	X	BS	L	X	2
Precharge all Banks	See Current State Table	H	X	L	L	H	L	X	X	H	X	
Bank Activate	Idle	H	X	L	L	H	H	X	BS	Row Address		2
Write	Active	H	X	L	H	L	L	X	BS	L	Column	2
Write with Auto-Precharge	Active	H	X	L	H	L	L	X	BS	H	Column	2
Read	Active	H	X	L	H	L	H	X	BS	L	Column	2
Read with Auto-Precharge	Active	H	X	L	H	L	H	X	BS	H	Column	2
Burst Termination	Active	H	X	L	H	H	L	X	X	X	X	3, 8
No Operation	Any	H	X	L	H	H	H	X	X	X	X	
Device Deselect	Any	H	X	H	X	X	X	X	X	X	X	
Clock Suspend Mode Entry	Active	H	L	X	X	X	X	X	X	X	X	4
Clock Suspend Mode Exit	Active	L	H	X	X	X	X	X	X	X	X	4
Data Write/Output Enable	Active	H	X	X	X	X	X	L	X	X	X	5
Data Mask/Output Disable	Active	H	X	X	X	X	X	H	X	X	X	5

1. All of the SDRAM operations are defined by states of $\overline{CS}$, $\overline{WE}$, $\overline{RAS}$, $\overline{CAS}$, and DQM at the positive rising edge of the clock.Operation of both decks of a stacked device at the same time is allowed, depending on the operation being performed on the other deck. Refer to the Current State Truth Table.
2. Bank Select (BS0, BS1): BS0, BS1 = 0,0 selects bank 0; BS0, BS1 = 0,1 selects bank 1; BS0, BS1 = 1,0 selects bank 2; BS0, BS1 = 1,1 selects bank 3.
3. During a Burst Write cycle there is a zero clock delay, for a Burst Read cycle the delay is equal to the $\overline{CAS}$ latency.
4. During normal access mode, CKE is held high and CLK is enabled. When it is low, it freezes the internal clock and extends data Read and Write operations. One clock delay is required for mode entry and exit.
5. The DQM has two functions for the data DQ Read and Write operations. During a Read cycle, when DQM goes high at a clock timing the data outputs are disabled and become high impedance after a two clock delay. DQM also provides a data mask function for Write cycles. When it activates, the Write operation at the clock is prohibited (zero clock latency).
6. All banks must be precharged before entering the Power Down Mode.(If this command is issued during a burst operation, the device state will be Clock Suspend Mode.)The Power Down Mode does not perform any refresh operations, therefore the device can't remain in this mode longer than the Refresh period (t_{REF}) of the device. One clock delay is required for mode entry and exit.
7. A No Operation or Device Deselect command is required on the next clock edge following CKE going high.
8. Device state is full page burst operation. Use of this command to terminate other burst length operations is illegal.

Command Truth Table (See note 1)

Function	Device State	CKE		$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	DQM	A12, A13	A10	A11, A9-A0	Notes
		Previous Cycle	Current Cycle									
Power Down Mode Entry	Idle/Active	H	L	H	X	X	X	X	X	X	X	6, 7
				L	H	H	H					
Power Down Mode Exit	Any (Power Down)	L	H	H	X	X	X	X	X	X	X	6, 7
				L	H	H	H					

1. All of the SDRAM operations are defined by states of $\overline{CS}$, $\overline{WE}$, $\overline{RAS}$, $\overline{CAS}$, and DQM at the positive rising edge of the clock. Operation of both decks of a stacked device at the same time is allowed, depending on the operation being performed on the other deck. Refer to the Current State Truth Table.
2. Bank Select (BS0, BS1): BS0, BS1 = 0,0 selects bank 0; BS0, BS1 = 0,1 selects bank 1; BS0, BS1 = 1,0 selects bank 2; BS0, BS1 = 1,1 selects bank 3.
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7. A No Operation or Device Deselect command is required on the next clock edge following CKE going high.
8. Device state is full page burst operation. Use of this command to terminate other burst length operations is illegal.

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Clock Enable (CKE) Truth Table

Current State	CKE		Command						Action	Notes
	Previous Cycle	Current Cycle	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	A12,A13	A11 - A0		
Self Refresh	H	X	X	X	X	X	X	X	INVALID	1
	L	H	H	X	X	X	X	X	Exit Self Refresh with Device Deselect	2
	L	H	L	H	H	H	X	X	Exit Self Refresh with No Operation	2
	L	H	L	H	H	L	X	X	ILLEGAL	2
	L	H	L	H	L	X	X	X	ILLEGAL	2
	L	H	L	L	X	X	X	X	ILLEGAL	2
	L	L	X	X	X	X	X	X	Maintain Self Refresh	
Power Down	H	X	X	X	X	X	X	X	INVALID	1
	L	H	H	X	X	X	X	X	Power Down mode exit, all banks idle	2
	L	H	L	X	X	X	X	X	ILLEGAL	2
	L	L	X	X	X	X	X	X	Maintain Power Down Mode	
All Banks Idle	H	H	H	X	X	X			Refer to the Idle State section of the Current State Truth Table	3
	H	H	L	H	X	X				3
	H	H	L	L	H	X				3
	H	H	L	L	L	H	X	X	CBR Refresh	
	H	H	L	L	L	L	OP Code		Mode Register Set	4
	H	L	H	X	X	X			Refer to the Idle State section of the Current State Truth Table	3
	H	L	L	H	X	X				3
	H	L	L	L	H	X				3
	H	L	L	L	L	H	X	X	Entry Self Refresh	4
	H	L	L	L	L	L	OP Code		Mode Register Set	
	L	X	X	X	X	X	X	X	Power Down	4
Any State other than listed above	H	H	X	X	X	X	X	X	Refer to operations in the Current State Truth Table	
	H	L	X	X	X	X	X	X	Begin Clock Suspend next cycle	5
	L	H	X	X	X	X	X	X	Exit Clock Suspend next cycle	
	L	L	X	X	X	X	X	X	Maintain Clock Suspend	

1. For the given Current State CKE must be low in the previous cycle.
2. When CKE has a low to high transition, the clock and other inputs are re-enabled asynchronously. The minimum setup time for CKE (t_{CES}) must be satisfied before any command other than Exit is issued. When exiting power-down mode, a NOP command (or a Device Deselect command) is required on the first rising clock after CKE goes high (see page 31).
3. The address inputs (A13 - A0) depend on the command that is issued. See the Idle State section of the Current State Truth Table for more information.
4. The Precharge Power Down Mode, Self Refresh Mode, and the Mode Register Set can only be entered from the all banks idle state.
5. Must be a legal command as defined in the Current State Truth Table.

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Current State Truth Table (Part 1 of 4)(See note 1)

Current State	CS	RAS	CAS	WE	A12,A13	A11 - A0	Description	Action	Notes
							Command		
Idle	L	L	L	L	OP Code		Mode Register Set	Set the Mode Register	2
	L	L	L	H	X	X	Auto or Self Refresh	Start Auto or Self Refresh	2, 3
	L	L	H	L	BS	X	Precharge	No Operation	
	L	L	H	H	BS	Row Address	Bank Activate	Activate the specified bank and row	
	L	H	L	L	BS	Column	Write w/o Precharge	ILLEGAL	4
	L	H	L	H	BS	Column	Read w/o Precharge	ILLEGAL	4
	L	H	H	L	X	X	Burst Termination	No Operation	
	L	H	H	H	X	X	No Operation	No Operation	
	H	X	X	X	X	X	Device Deselect	No Operation or Power Down	5
Row Active	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	Precharge	6
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	Start Write; Determine if Auto Precharge	7, 8
	L	H	L	H	BS	Column	Read	Start Read; Determine if Auto Precharge	7, 8
	L	H	H	L	X	X	Burst Termination	No Operation	
	L	H	H	H	X	X	No Operation	No Operation	
	H	X	X	X	X	X	Device Deselect	No Operation	
Read	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	Terminate Burst; Start the Precharge	
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	Terminate Burst; Start the Write cycle	8, 9
	L	H	L	H	BS	Column	Read	Terminate Burst; Start a new Read cycle	8, 9
	L	H	H	L	X	X	Burst Termination	Terminate the Burst	
	L	H	H	H	X	X	No Operation	Continue the Burst	
	H	X	X	X	X	X	Device Deselect	Continue the Burst	

1. CKE is assumed to be active (high) in the previous cycle for all entries. The Current State is the state of the bank that the Command is being applied to.
2. All Banks must be idle; otherwise, it is an illegal action.
3. If CKE is active (high) the SDRAM will start the Auto (CBR) Refresh operation, if CKE is inactive (low) than the Self Refresh mode is entered.
4. The Current State refers to only one of the banks. If BS selects this bank then the action is illegal. If BS selects the bank not being referenced by the Current State then the action may be legal depending on the state of that bank.
5. If CKE is inactive (low) then the Power Down mode is entered, otherwise there is a No Operation.
6. The minimum and maximum Active time (t_{RAS}) must be satisfied.
7. The $\overline{RAS}$ to $\overline{CAS}$ Delay (t_{RCD}) must occur before the command is given.
8. Column address A10 is used to determine if the Auto Precharge function is activated.
9. The command must satisfy any bus contention, bus turn around, and/or write recovery requirements.
10. The command is illegal if the minimum bank to bank delay time (t_{RRD}) is not satisfied.

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Current State Truth Table (Part 2 of 4)(See note 1)

Current State	CS	RAS	CAS	WE	A12,A13	A11 - A0	Description	Action	Notes
					Command			Action	Notes
Write	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	Terminate Burst; Start the Precharge	
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	Terminate Burst; Start a new Write cycle	8, 9
	L	H	L	H	BS	Column	Read	Terminate Burst; Start the Read cycle	8, 9
	L	H	H	L	X	X	Burst Termination	Terminate the Burst	
	L	H	H	H	X	X	No Operation	Continue the Burst	
	H	X	X	X	X	X	Device Deselect	Continue the Burst	
Read with Auto Pre-charge	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	4
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	ILLEGAL	4
	L	H	L	H	BS	Column	Read	ILLEGAL	4
	L	H	H	L	X	X	Burst Termination	ILLEGAL	
	L	H	H	H	X	X	No Operation	Continue the Burst	
	H	X	X	X	X	X	Device Deselect	Continue the Burst	
Write with Auto Pre-charge	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	4
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	ILLEGAL	4
	L	H	L	H	BS	Column	Read	ILLEGAL	4
	L	H	H	L	X	X	Burst Termination	ILLEGAL	
	L	H	H	H	X	X	No Operation	Continue the Burst	
	H	X	X	X	X	X	Device Deselect	Continue the Burst	

1. CKE is assumed to be active (high) in the previous cycle for all entries. The Current State is the state of the bank that the Command is being applied to.
2. All Banks must be idle; otherwise, it is an illegal action.
3. If CKE is active (high) the SDRAM will start the Auto (CBR) Refresh operation, if CKE is inactive (low) than the Self Refresh mode is entered.
4. The Current State refers to only one of the banks. If BS selects this bank then the action is illegal. If BS selects the bank not being referenced by the Current State then the action may be legal depending on the state of that bank.
5. If CKE is inactive (low) then the Power Down mode is entered, otherwise there is a No Operation.
6. The minimum and maximum Active time (t_{RAS}) must be satisfied.
7. The $\overline{RAS}$ to $\overline{CAS}$ Delay (t_{RCD}) must occur before the command is given.
8. Column address A10 is used to determine if the Auto Precharge function is activated.
9. The command must satisfy any bus contention, bus turn around, and/or write recovery requirements.
10. The command is illegal if the minimum bank to bank delay time (t_{RRD}) is not satisfied.

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Current State Truth Table (Part 3 of 4)(See note 1)

Current State	Command							Action	Notes
	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	A12,A13	A11 - A0	Description		
Precharging	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	No Operation; Bank(s) idle after t_{RP}	
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	ILLEGAL	4
	L	H	L	H	BS	Column	Read	ILLEGAL	4
	L	H	H	L	X	X	Burst Termination	No Operation; Bank(s) idle after t_{RP}	
	L	H	H	H	X	X	No Operation	No Operation; Bank(s) idle after t_{RP}	
	H	X	X	X	X	X	Device Deselect	No Operation; Bank(s) idle after t_{RP}	
Row Activating	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	4
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4, 10
	L	H	L	L	BS	Column	Write	ILLEGAL	4
	L	H	L	H	BS	Column	Read	ILLEGAL	4
	L	H	H	L	X	X	Burst Termination	No Operation; Row Active after t_{RCD}	
	L	H	H	H	X	X	No Operation	No Operation; Row Active after t_{RCD}	
	H	X	X	X	X	X	Device Deselect	No Operation; Row Active after t_{RCD}	
Write Recovering	L	L	L	L	OP Code		Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	4
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	4
	L	H	L	L	BS	Column	Write	Start Write; Determine if Auto Precharge	9
	L	H	L	H	BS	Column	Read	Start Read; Determine if Auto Precharge	9
	L	H	H	L	X	X	Burst Termination	No Operation; Row Active after t_{DPL}	
	L	H	H	H	X	X	No Operation	No Operation; Row Active after t_{DPL}	
	H	X	X	X	X	X	Device Deselect	No Operation; Row Active after t_{DPL}	

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4. The Current State refers to only one of the banks. If BS selects this bank then the action is illegal. If BS selects the bank not being referenced by the Current State then the action may be legal depending on the state of that bank.
5. If CKE is inactive (low) then the Power Down mode is entered, otherwise there is a No Operation.
6. The minimum and maximum Active time (t_{RAS}) must be satisfied.
7. The $\overline{RAS}$ to $\overline{CAS}$ Delay (t_{RCD}) must occur before the command is given.
8. Column address A10 is used to determine if the Auto Precharge function is activated.
9. The command must satisfy any bus contention, bus turn around, and/or write recovery requirements.
10. The command is illegal if the minimum bank to bank delay time (t_{RRD}) is not satisfied.

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Current State Truth Table (Part 4 of 4)(See note 1)

Current State	CS̄	RAS̄	CAS̄	WĒ	A12,A13	A11 - A0	Description	Action	Notes
						Command		Action	Notes
Write Recovering with Auto Pre-charge	L	L	L	L		OP Code	Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	4
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	
	L	H	L	L	BS	Column	Write	ILLEGAL	4, 9
	L	H	L	H	BS	Column	Read	ILLEGAL	4, 9
	L	H	H	L	X	X	Burst Termination	No Operation; Precharge after t_{DPL}	
	L	H	H	H	X	X	No Operation	No Operation; Precharge after t_{DPL}	
	H	X	X	X	X	X	Device Deselect	No Operation; Precharge after t_{DPL}	
Refreshing	L	L	L	L		OP Code	Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	
	L	H	L	L	BS	Column	Write	ILLEGAL	
	L	H	L	H	BS	Column	Read	ILLEGAL	
	L	H	H	L	X	X	Burst Termination	No Operation; Idle after t_{RC}	
	L	H	H	H	X	X	No Operation	No Operation; Idle after t_{RC}	
	H	X	X	X	X	X	Device Deselect	No Operation; Idle after t_{RC}	
Mode Register Accessing	L	L	L	L		OP Code	Mode Register Set	ILLEGAL	
	L	L	L	H	X	X	Auto or Self Refresh	ILLEGAL	
	L	L	H	L	BS	X	Precharge	ILLEGAL	
	L	L	H	H	BS	Row Address	Bank Activate	ILLEGAL	
	L	H	L	L	BS	Column	Write	ILLEGAL	
	L	H	L	H	BS	Column	Read	ILLEGAL	
	L	H	H	L	X	X	Burst Termination	ILLEGAL	
	L	H	H	H	X	X	No Operation	No Operation; Idle after two clock cycles	
	H	X	X	X	X	X	Device Deselect	No Operation; Idle after two clock cycles	

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4. The Current State refers to only one of the banks. If BS selects this bank then the action is illegal. If BS selects the bank not being referenced by the Current State then the action may be legal depending on the state of that bank.
5. If CKE is inactive (low) then the Power Down mode is entered, otherwise there is a No Operation.
6. The minimum and maximum Active time (t_{RAS}) must be satisfied.
7. The RAS̄ to CAS̄ Delay (t_{RCD}) must occur before the command is given.
8. Column address A10 is used to determine if the Auto Precharge function is activated.
9. The command must satisfy any bus contention, bus turn around, and/or write recovery requirements.
10. The command is illegal if the minimum bank to bank delay time (t_{RRD}) is not satisfied.

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Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	Notes
V_{DD}	Power Supply Voltage	-0.3 to +4.6	V	1
V_{DDQ}	Power Supply Voltage for Output	-0.3 to +4.6	V	1
V_{IN}	Input Voltage	-0.3 to V_{DD}+0.3	V	1
V_{OUT}	Output Voltage	-0.3 to V_{DD}+0.3	V	1
T_A	Operating Temperature (ambient)	0 to +70	°C	1
T_{STG}	Storage Temperature	-55 to +125	°C	1
P_D	Power Dissipation	1.0	W	1
I_{OUT}	Short Circuit Output Current	50	mA	1

1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Recommended DC Operating Conditions (T_A = 0 to 70°C)

Symbol	Parameter	Rating			Units	Notes
		Min.	Typ.	Max.		
V_{DD}	Supply Voltage	3.0	3.3	3.6	V	1
V_{DDQ}	Supply Voltage for Output	3.0	3.3	3.6	V	1
V_{IH}	Input High Voltage	2.0	—	V_{DD} + 0.3	V	1, 2
V_{IL}	Input Low Voltage	-0.3	—	0.8	V	1, 3

1. All voltages referenced to V_{SS} and V_{SSQ}.
2. V_{IH} (max) = V_{DD}/V_{DDQ} + 1.2V for pulse width ≤ 5ns.
3. V_{IL} (min) = V_{SS}/V_{SSQ} - 1.2V for pulse width ≤ 5ns.

Capacitance (T_A = 25°C, f = 1MHz, V_{DD} = 3.3V ±0.3V)

Symbol	Parameter	Min.	Typ.	Max.	Units	Notes
C_I	Input Capacitance (A0-A11, BS0, BS1, $\overline{CS}$, $\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, CKE, DQM)	2.5	2.9	4.0	pF	1
	Input Capacitance (CLK)	2.5	3.2	4.0	pF	1
C_O	Output Capacitance (DQ0 - DQ15)	4.0	5.4	6.5	pF	1

1. Multiply given planar values by 2 for 2-high stacked device except $\overline{CS}$.

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DC Electrical Characteristics (T_A = 0 to +70°C, V_{DD} = 3.3V ±0.3V)

Symbol	Parameter	Min.	Max.	Units	Notes
$I_{I(L)}$	Input Leakage Current, any input (0.0V ≤ V_{IN} ≤ V_{DD}), All Other Pins Not Under Test = 0V	-2	+2	µA	1
$I_{O(L)}$	Output Leakage Current (D_{OUT} is disabled, 0.0V ≤ V_{OUT} ≤ V_{DDQ})	-2	+2	µA	1
V_{OH}	Output Level (LVTTL) Output "H" Level Voltage (I_{OUT} = -2.0mA)	2.4	—	V	
V_{OL}	Output Level (LVTTL) Output "L" Level Voltage (I_{OUT} = +2.0mA)	—	0.4	V	

1. Multiply given planar values by 2 for 2-high stacked device.

DC Output Load Circuit

3.3V

1200Ω

Output

V_{OH} (DC) = 2.4V, I_{OH} = -2mA

V_{OL} (DC) = 0.4V, I_{OL} = 2mA

870Ω   50pF
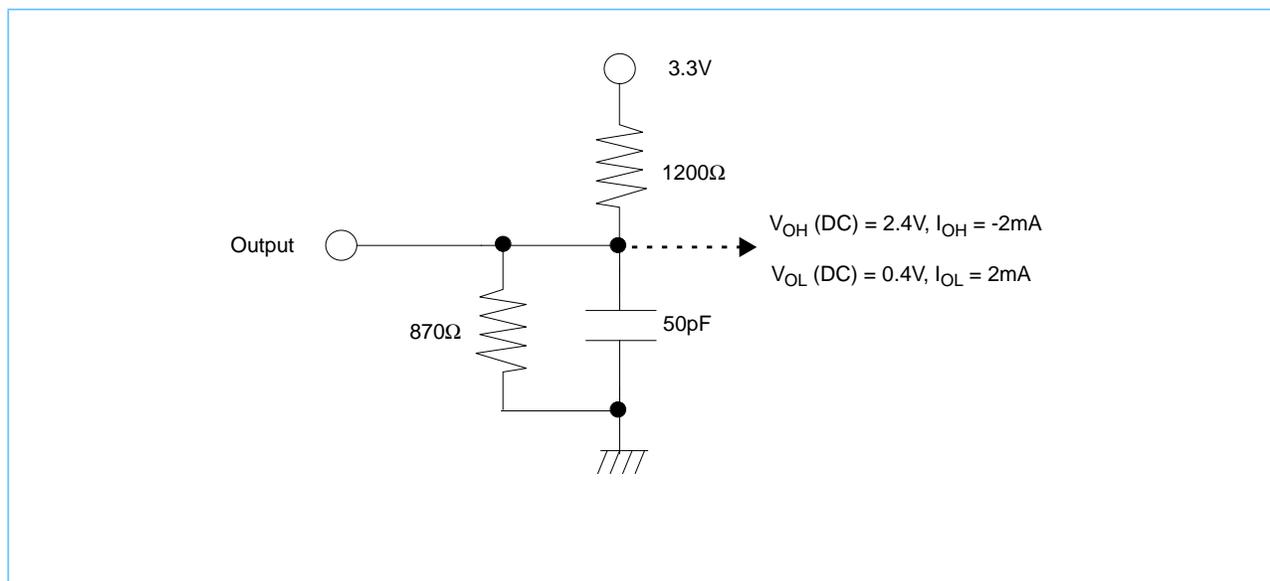
Operating, Standby, and Refresh Currents (T_A = 0 to +70°C, V_{DD} = 3.3V ± 0.3V)

Parameter	Symbol	Test Condition	Speed				Units	Notes
			-68	-260	-360	-10		
Operating Current	I_{CC1}	1 bank operation $t_{RC} = t_{RC}$(min), t_{CK} = min Active-Precharge command cycling without burst operation	75	75	75	55	mA	1, 2, 3
Precharge Standby Current in Power Down Mode	I_{CC2P}	CKE ≤ V_{IL}(max), t_{CK} = min, $\overline{CS}$ =V_{IH}(min)	1	1	1	1	mA	1
	I_{CC2PS}	CKE ≤ V_{IL}(max), t_{CK} = Infinity, $\overline{CS}$ =V_{IH}(min)	1	1	1	1	mA	1
Precharge Standby Current in Non-Power Down Mode	I_{CC2N}	CKE ≥ V_{IH}(min), t_{CK} = min, $\overline{CS}$ =V_{IH} (min)	40	35	35	25	mA	1, 5
	I_{CC2NS}	CKE ≥ V_{IH}(min), t_{CK} = Infinity,	5	5	5	5	mA	1, 7
No Operating Current (Active state: 4 bank)	I_{CC3N}	CKE ≥ V_{IH}(min), t_{CK} = min, $\overline{CS}$ =V_{IH} (min)	45	40	40	30	mA	1, 5
	I_{CC3P}	CKE ≤ V_{IL}(max), t_{CK} = min,	7	7	7	7	mA	1, 6
Operating Current (Burst Mode)	I_{CC4}	t_{CK} = min, Read/ Write command cycling, Multiple banks active, gapless data,BL=4	130	120	120	90	mA	1, 3, 4
Auto (CBR) Refresh Current	I_{CC5}	t_{CK} = min, $t_{RC} = t_{RC}$(min) CBR command cycling	145	145	145	110	mA	1
Self Refresh Current	I_{CC6}	CKE ≤ 0.2V SP	1	1	1	1	mA	1, 8
		LP	400	400	400	400	µA	

1. Currents given are valid for a single device. The total current for a stacked device depends on the operation being performed on the other deck.
2. These parameters depend on the cycle rate and are measured with the cycle determined by the minimum value of t_{CK} and t_{RC}. Input signals are changed up to three times during t_{RC}(min).
3. The specified values are obtained with the output open.
4. Input signals are changed once during t_{CK}(min).
5. Input signals are changed once during three clock cycles.
6. Active Standby Current will be higher if Clock Suspend is entered during a burst read cycle (add 1mA per DQ).
7. Input signals are stable.
8. SP: Standard power; LP: Low power.

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AC Characteristics (T_A = 0 to +70°C, V_{DD} = 3.3V ± 0.3V)

1. An initial pause of 200μs, with DQM and CKE held high, is required after power-up. A Precharge All Banks command must be given followed by a minimum of eight Auto (CBR) Refresh cycles before or after the Mode Register Set operation.
2. The Transition time is measured between V_{IH} and V_{IL} (or between V_{IL} and V_{IH}).
3. In addition to meeting the transition rate specification, the clock and CKE must transit between V_{IH} and V_{IL} (or between V_{IL} and V_{IH}) in a monotonic manner.
4. Load Circuit A: AC timing tests have V_{IL} = 0.4 V and V_{IH} = 2.4 V with the timing referenced to the 1.40V crossover point
5. Load Circuit A: AC measurements assume t_T = 1.0 ns.
6. Load Circuit B: AC timing tests have V_{IL} = 0.8 V and V_{IH} = 2.0 V with the timing referenced to the 1.40V crossover point
7. Load Circuit B: AC measurements assume t_T = 1.2 ns.

AC Output Load Circuits
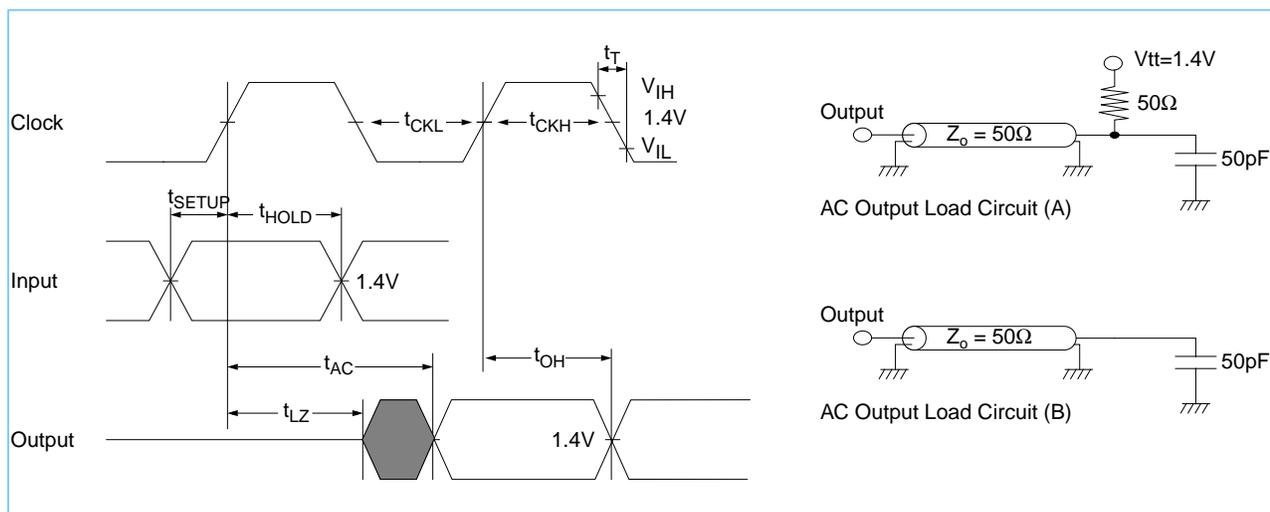
Clock and Clock Enable Parameters

Symbol	Parameter	-68		-260		-360		-10		Units	Notes
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t_{CK3}	Clock Cycle Time, $\overline{CAS}$ Latency = 3	6.8	1000	7.4	1000	7.4	1000	10	1000	ns	
t_{CK2}	Clock Cycle Time, $\overline{CAS}$ Latency = 2	12	1000	10	1000	15	1000	15	1000	ns	
$t_{AC3 (A)}$	Clock Access Time, $\overline{CAS}$ Latency = 3	—	6	—	—	—	—	—	7	ns	1
$t_{AC2 (A)}$	Clock Access Time, $\overline{CAS}$ Latency = 2	—	7	—	—	—	—	—	8	ns	1
$t_{AC3 (B)}$	Clock Access Time, $\overline{CAS}$ Latency = 3	—	—	—	6	—	6	—	9	ns	2
$t_{AC2 (B)}$	Clock Access Time, $\overline{CAS}$ Latency = 2	—	—	—	6	—	9	—	9	ns	2
t_{CKH}	Clock High Pulse Width	3	—	3	—	3	—	3	—	ns	
t_{CKL}	Clock Low Pulse Width	3	—	3	—	3	—	3	—	ns	
t_{CES}	Clock Enable Set-up Time	2	—	1.8	—	1.8	—	3	—	ns	
t_{CEH}	Clock Enable Hold Time	1	—	0.8	—	0.8	—	1	—	ns	
t_{SB}	Power down mode Entry Time	0	6.8	0	7.4	0	7.4	0	10	ns	
t_T	Transition Time (Rise and Fall)	0.5	10	0.5	10	0.5	10	0.5	10	ns	

1. Access time is measured at 1.4V. See AC Characteristics, notes 1, 2, 3, 4, and 5 and load circuit A.
2. Access time is measured at 1.4V. See AC Characteristics, notes 1, 2, 3, 6, and 7 and load circuit B.

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Common Parameters

Symbol	Parameter	-68		-260		-360		-10		Units	Notes
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t_{CS}	Command Setup Time	2	—	1.8	—	1.8	—	3	—	ns	
t_{CH}	Command Hold Time	1	—	0.8	—	0.8	—	1	—	ns	
t_{AS}	Address and Bank Select Set-up Time	2	—	1.8	—	1.8	—	3	—	ns	
t_{AH}	Address and Bank Select Hold Time	1	—	0.8	—	0.8	—	1	—	ns	
t_{RCD}	$\overline{RAS}$ to $\overline{CAS}$ Delay	20.4	—	20	—	20	—	30	—	ns	1
t_{RC}	Bank Cycle Time	68	—	66	—	66	—	90	—	ns	1
t_{RAS}	Active Command Period	47.6	100000	44	100000	44	100000	60	100000	ns	1
t_{RP}	Precharge Time	20.4	—	20	—	20	—	30	—	ns	1
t_{RRD}	Bank to Bank Delay Time	13.6	—	14	—	14	—	20	—	ns	1
t_{CCD}	$\overline{CAS}$ to $\overline{CAS}$ Delay Time	1	—	1	—	1	—	1	—	CLK	

1. These parameters account for the number of clock cycles and depend on the operating frequency of the clock, as follows: the number of clock cycles = specified value of timing / clock period (count fractions as a whole number).

Mode Register Set Cycle

Symbol	Parameter	-68		-260		-360		-10		Units	Notes
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t_{RSC}	Mode Register Set Cycle Time	13.6	—	14	—	14	—	20	—	ns	1

1. These parameters account for the number of clock cycles and depend on the operating frequency of the clock, as follows: the number of clock cycles = specified value of timing / clock period (count fractions as a whole number).

Read Cycle

Symbol	Parameter	-68		-260		-360		-10		Units	Notes
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t_{OH}	Data Out Hold Time	2.5	—	2.5	—	2.5	—	3	—	ns	1
		3	—	3	—	3	—	3	—	ns	2
t_{LZ}	Data Out to Low Impedance Time	0	—	0	—	0	—	0	—	ns	
t_{HZ3}	Data Out to High Impedance Time	3	6	3	6	3	6	3	7	ns	3
t_{HZ2}	Data Out to High Impedance Time	3	6	3	6	3	8	3	8	ns	3
t_{DQZ}	DQM Data Out Disable Latency	2	—	2	—	2	—	2	—	CLK	

1. AC Output Load Circuit A.
2. AC Output Load Circuit B.
3. Referenced to the time at which the output achieves the open circuit condition, not to output voltage levels.

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Refresh Cycle

Symbol	Parameter	-68		-260		-360		-10		Units	Notes
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t_{REF}	Refresh Period	—	64	—	64	—	64	—	64	ms	1
t_{SREX}	Self Refresh Exit Time	10		10		10		10		ns	

1. 4096 auto refresh cycles.

Write Cycle

Symbol	Parameter	-68		-260		-360		-10		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t_{DS}	Data In Set-up Time	2	—	1.8	—	1.8	—	3	—	ns
t_{DH}	Data In Hold Time	1	—	0.8	—	0.8	—	1	—	ns
t_{DPL}	Data input to Precharge	1	—	1	—	1	—	1	—	CLK
t_{DQW}	DQM Write Mask Latency	0	—	0	—	0	—	0	—	CLK

Clock Frequency and Latency

Symbol	Parameter	-68		-260			-360			-10		Units
f_{CK}	Clock Frequency	147	83	135	100	100	135	100	66	100	66	MHz
t_{CK}	Clock Cycle Time	6.8	12	7.4	10	10	7.4	10	15	10	15	ns
t_{AA}	$\overline{CAS}$ Latency	**3**	**2**	**3**	**3**	**2**	**3**	**3**	**2**	**3**	**2**	CLK
t_{RP}	Precharge Time	**3**	**2**	**3**	**2**	**2**	**3**	**2**	**2**	**3**	**2**	CLK
t_{RCD}	$\overline{RAS}$ to $\overline{CAS}$ Delay	**3**	**2**	**3**	**2**	**2**	**3**	**2**	**2**	**3**	**2**	CLK
t_{RC}	Bank Cycle Time	10	6	9	7	7	9	7	5	9	6	CLK
t_{RAS}	Minimum Bank Active Time	7	4	6	5	5	6	5	3	6	4	CLK
t_{DPL}	Data In to Precharge	1	1	1	1	1	1	1	1	1	1	CLK
t_{DAL}	Data In to Active/Refresh	4	3	4	3	3	4	3	3	4	3	CLK
t_{RRD}	Bank to Bank Delay Time	2	2	2	2	2	2	2	2	2	2	CLK
t_{CCD}	$\overline{CAS}$ to $\overline{CAS}$ Delay Time	1	1	1	1	1	1	1	1	1	1	CLK
t_{WL}	Write Latency	0	0	0	0	0	0	0	0	0	0	CLK
t_{DQW}	DQM Write Mask Latency	0	0	0	0	0	0	0	0	0	0	CLK
t_{DQZ}	DQM Data Disable Latency	2	2	2	2	2	2	2	2	2	2	CLK
t_{CSL}	Clock Suspend Latency	1	1	1	1	1	1	1	1	1	1	CLK

Timing Diagrams   Page

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IBM03648O4   IBM0364164

AC Parameters for Write Timing

$(\overline{CAS}$ Latency = 2; Burst Length = 4)

*BS0=" L"

Bank2,3=Idle

| Activate Command Bank 0 | Write with Auto Precharge Command Bank 0 | Activate Command Bank 1 | Write with Auto Precharge Command Bank 1 | Activate Command Bank 0 | Write Command Bank 0 | Precharge Command Bank 0 | Activate Command Bank 0 | Activate Command Bank 1 |

AC Parameters for Read Timing (3/3/3)

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($\overline{CAS}$ Latency = 3; Burst Length = 4; t_{RCD}, t_{RP} = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 |

CLK

t_{CK3}

CKE

Begin Auto Precharge Bank 0

Begin Auto Precharge Bank 1

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RAx — RBx — RAy

A0-A9,A11 — RAx — CAx — RBx — CBx — RAy

t_{RRD}

t_{RAS}

t_{RC}

t_{RP}

DQM

t_{AC3} t_{OH}

t_{RCD}

DQ   Hi-Z — Ax0 — Ax1 — Ax2 — Ax3 — Bx0 — Bx1 — Bx2

Activate Command Bank 0

Read with Auto Precharge Command Bank 0

Activate Command Bank 1

Read with Auto Precharge Command Bank 1

Activate Command Bank 0

* BS0=" L"
Bank2,3=Idle

Discontinued (8/99 - last order; 12/99 - last ship)

AC Parameters for Read Timing (2/2/2)

($\overline{CAS}$ Latency = 2; Burst Length = 2; t_{RCD}, t_{RP} = 2)

	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13

CLK

t_{CKH} t_{CKL} t_{CK2}

CKE

t_{CS} t_{CES} t_{CH}

Begin Auto Precharge Bank 0

Begin Auto Precharge Bank 1

t_{CEH}

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10   RAx   RBx   RAy

t_{AH}

A0-A9,A11   RAx   CAx   RBx   CBx   RAy

t_{AS}

t_{RRD}

$t_{RAS(min)}$ t_{RP}

DQM

t_{RC}

Note: Must satisfy $t_{RAS(min)}$
For -260: extend t_{RCD} 1 clock

t_{AC2} t_{OH}

t_{HZ}

t_{RCD}

t_{LZ}

t_{RP}

t_{HZ}

DQ   Hi-Z   Ax0   Ax1   Bx0   Bx1

Activate Command Bank 0

Read with Auto Precharge Command Bank 0

Activate Command Bank 1

Read with Auto Precharge Command Bank 1

Activate Command Bank 0

* BS0=" L"
Bank2,3=Idle

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AC Parameters for Read Timing (3/2/2)

($\overline{CAS}$ Latency = 3; Burst Length = 2; t_{RCD}, t_{RP} = 2)
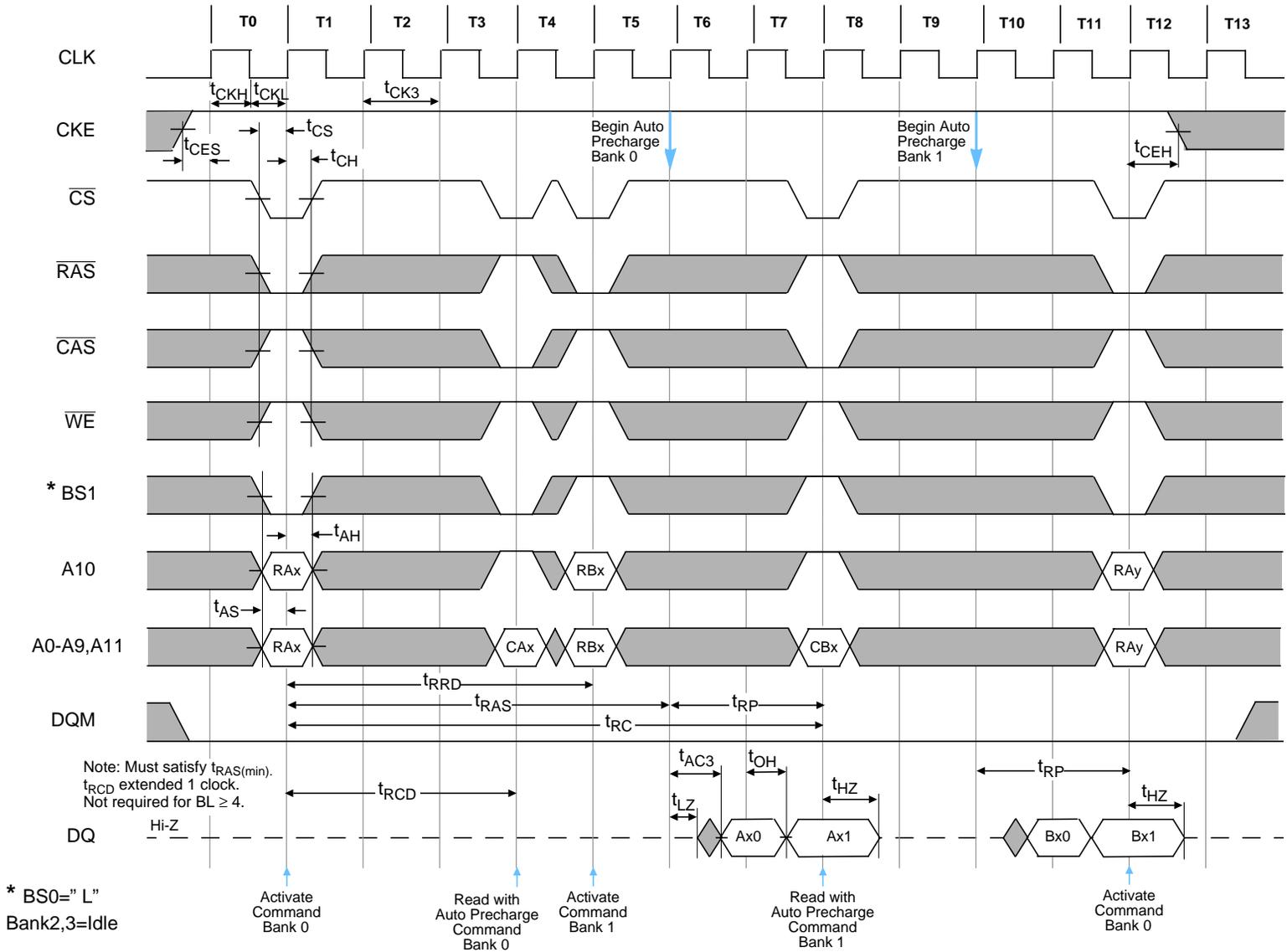
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AC Parameters for Read Timing (3/3/3)

($\overline{CAS}$ Latency = 3; Burst Length = 2; t_{RCD}, t_{RP} = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 |

CLK

t_{CK3}

CKE

Begin Auto Precharge Bank 0

Begin Auto Precharge Bank 1

t_{CEH}

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10   RAx   RBx   RAy

A0-A9, A11   RAx   CAx   RBx   CBx   RAy

t_{RRD}

$t_{RAS\ (min)}$

t_{RP}

t_{RC}

DQM

t_{AC3} t_{OH}

t_{RP}

t_{RCD}

DQ   Hi-Z   Ax0   Ax1   Bx0   Bx1

Activate Command Bank 0
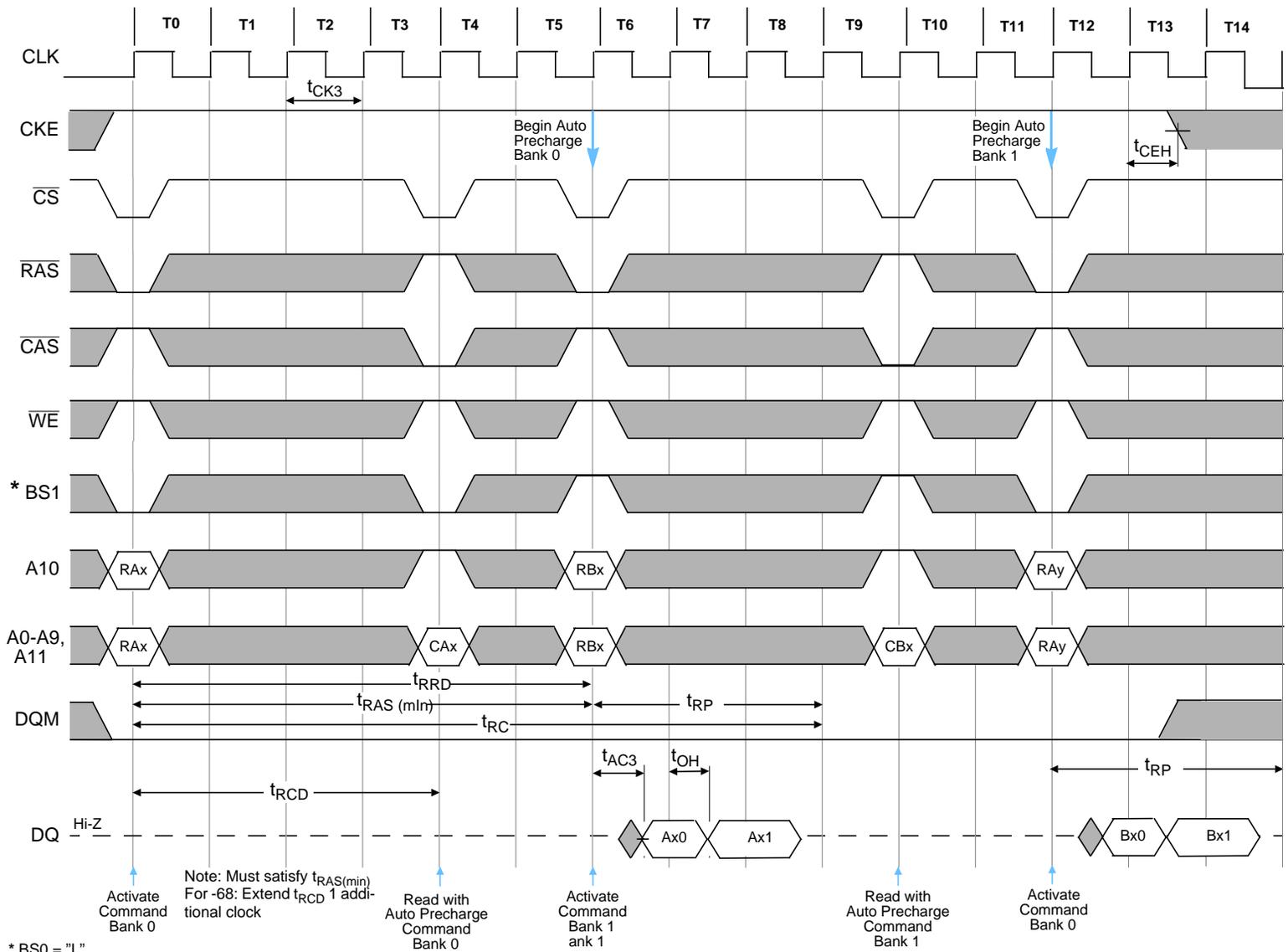
Note: Must satisfy $t_{RAS(min)}$
For -68: Extend t_{RCD} 1 additional clock

Read with Auto Precharge Command Bank 0

Activate Command Bank 1 ank 1

Read with Auto Precharge Command Bank 1

Activate Command Bank 0

* BS0 = "L"

Bank 2, 3 = Idle

Mode Register Set

($\overline{\text{CAS}}$ Latency = 2)

Timing diagram signals: CLK, CKE, $\overline{\text{CS}}$, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$, BS0,BS1, A10,A11, A0-A9, DQM, DQ

Clock cycles: T0 through T22

Timing parameters: t_{CK2}, t_{RSC}, t_{RP}

Labels: Address Key, Hi-Z

Precharge Command All Banks, Mode Register Set Command, Any Command

Discontinued (8/99 - last order; 12/99 - last ship)

Power On Sequence and Auto Refresh (CBR)
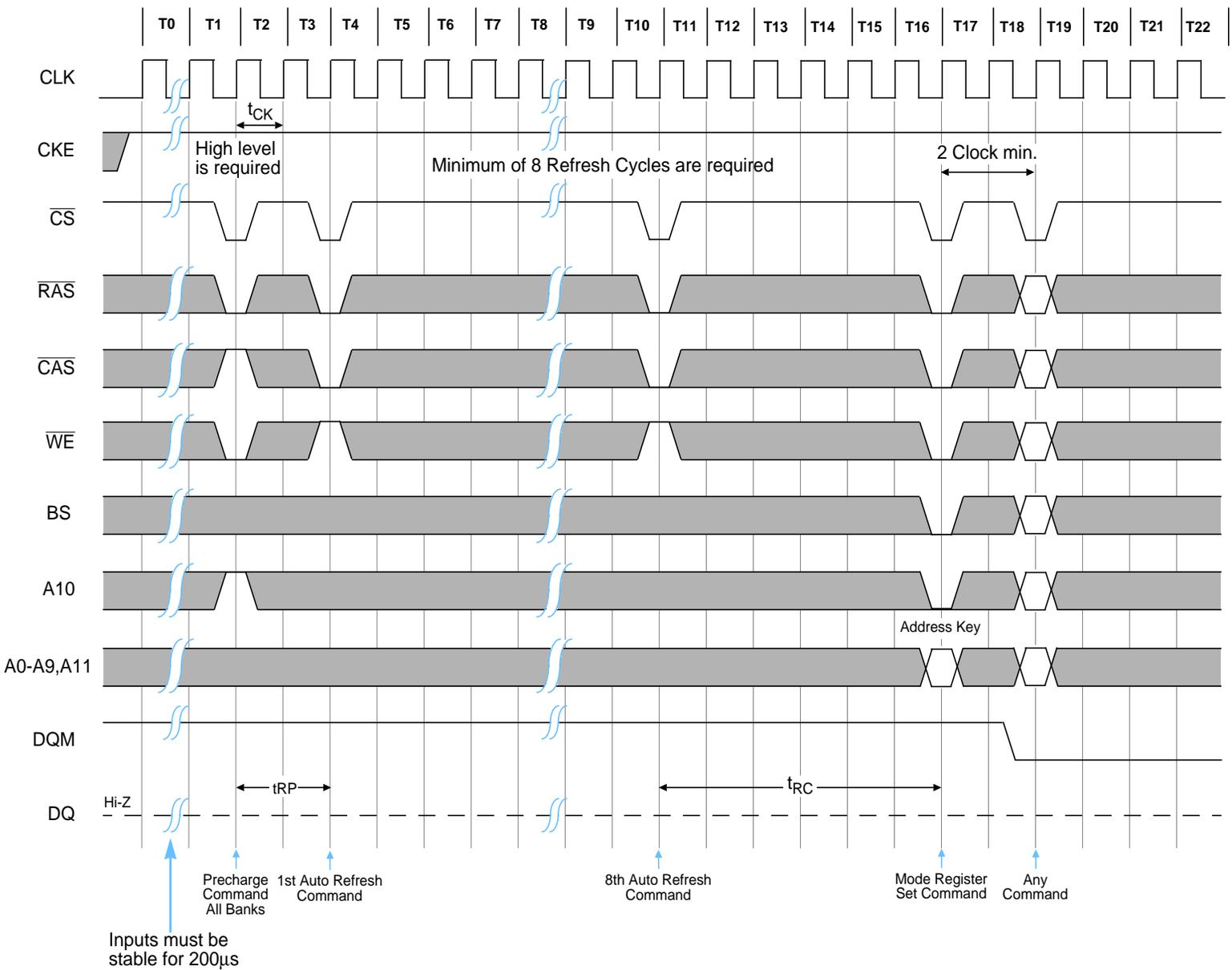
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1/28/99

| T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

CKE — High level is required — Minimum of 8 Refresh Cycles are required — 2 Clock min.

t_{CK}

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

BS

A10

A0-A9,A11 — Address Key

DQM

DQ — Hi-Z

t_{RP} t_{RC}

Precharge Command All Banks
1st Auto Refresh Command
8th Auto Refresh Command
Mode Register Set Command
Any Command

Inputs must be stable for 200µs

Clock Suspension, DQM during Burst Read

Discontinued (8/99 - last order; 12/99 - last ship)

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$(\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD} = 3)

CLK

CKE

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10

A0-A9,A11

DQM

DQ

T0 T1 T2 T3 T4 T5 T6 T7 T8 T9 T10 T11 T12 T13 T14 T15 T16 T17 T18 T19 T20 T21 T22

t_{CK3}

t_{CES} t_{CEH}

t_{HZ}

RAx

RAx   CAx

Ax0 Ax1 Ax2 Ax3 Ax4 Ax6 Ax7

Hi-Z

Activate Command Bank 0

Read Command Bank 0

Clock Suspend 1 Cycle

Clock Suspend 2 Cycles

Clock Suspend 3 Cycles
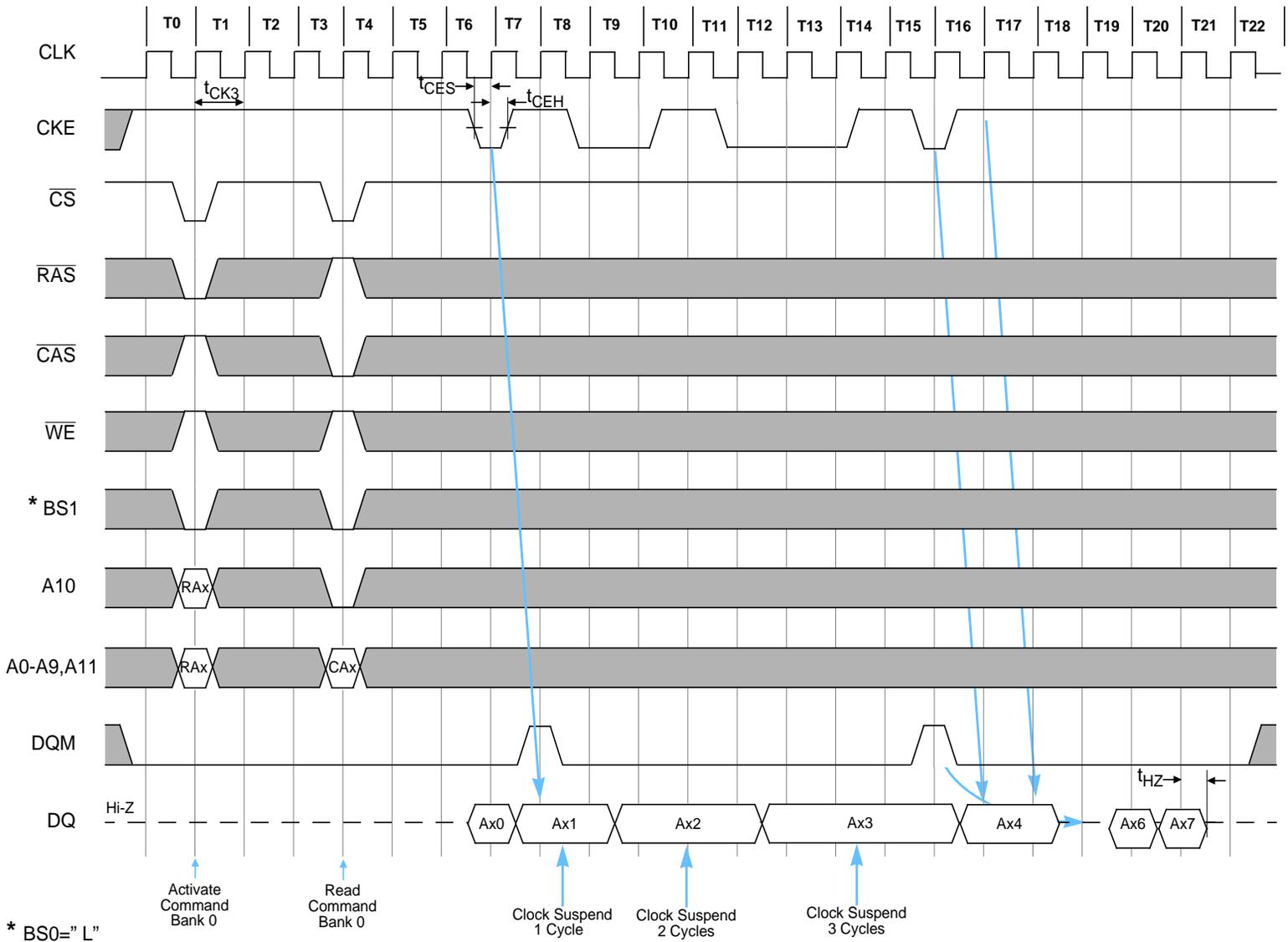
* BS0=" L"
Bank2,3=Idle

Clock Suspension, DQM during Burst Write

($\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD} = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

t_{CK3}

CKE

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10   RAx

A0-A9,A11   RAx   CAx

DQM

DQ   Hi-Z   DAx0 DAx1 DAx2 DAx3 DAx5 DAx6 DAx7

Activate
Command
Bank 0

Write
Command
Bank 0

Clock Suspend
1 Cycle

Clock Suspend
2 Cycles

Clock Suspend
3 Cycles

* BS0=" L"
Bank2,3=Idle

Power Down Mode and Clock Suspend
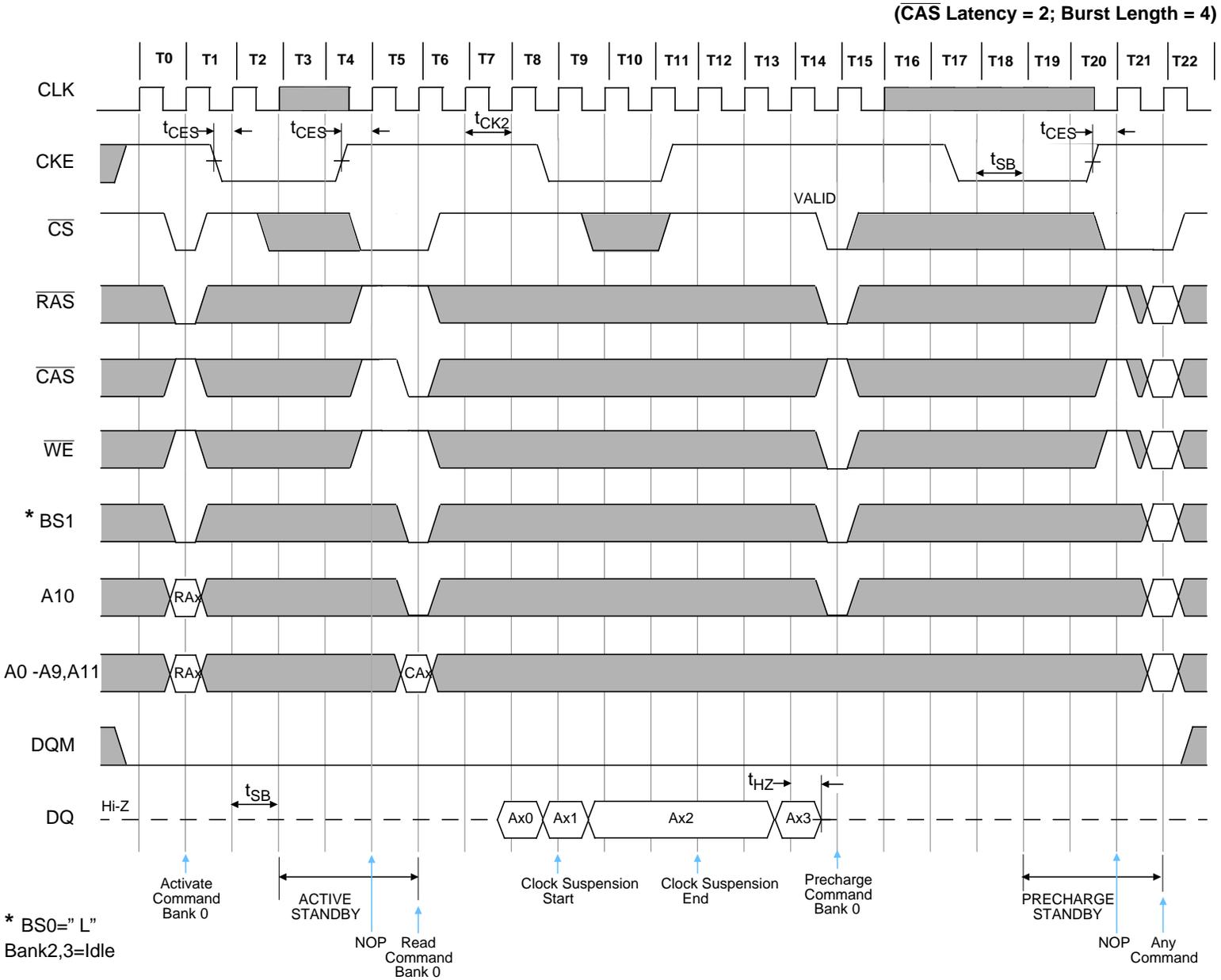
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($\overline{CAS}$ Latency = 2; Burst Length = 4)

| T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

CKE t_{CES} t_{CES} t_{CK2} t_{SB} t_{CES}

$\overline{CS}$ VALID

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10   RAx

A0 -A9,A11   RAx   CAx

DQM

DQ   Hi-Z t_{SB} Ax0 Ax1 Ax2 Ax3 t_{HZ}

Activate
Command
Bank 0

ACTIVE
STANDBY

NOP   Read
Command
Bank 0

Clock Suspension
Start

Clock Suspension
End

Precharge
Command
Bank 0

PRECHARGE
STANDBY

NOP   Any
Command

* BS0=" L"
Bank2,3=Idle

Auto Refresh (CBR)

($\overline{CAS}$ Latency = 2)
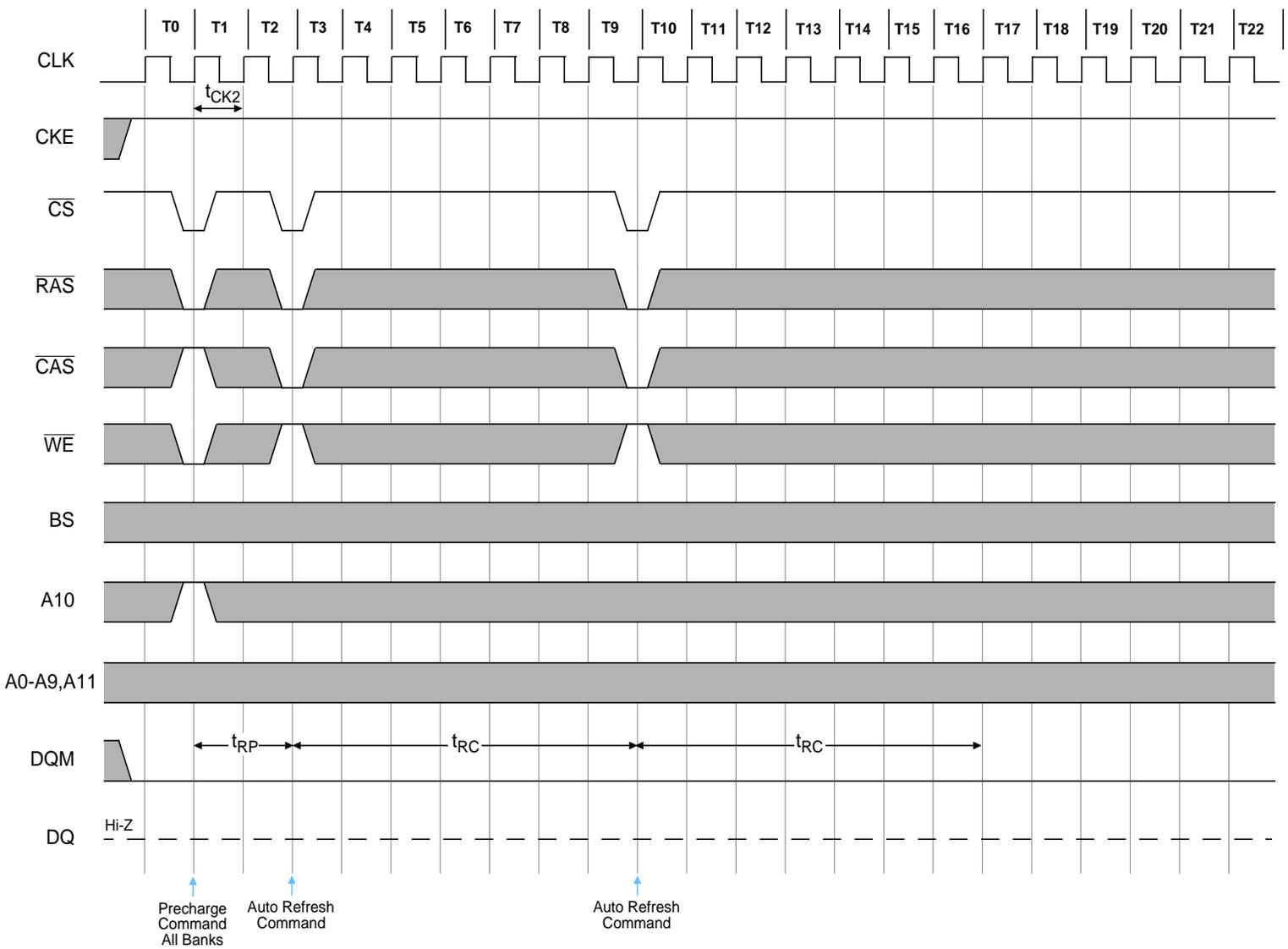
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Self Refresh (Entry and Exit)

(Note: The CLK signal must be reestablished prior to CKE returning high)

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64Mb Synchronous DRAM - Die Revision B

| | T0 | T1 | T2 | T3 | T4 | | | Tm | Tm+1 | Tm+2 | Tm+3 | Tm+4 | Tm+5 | Tm+6 | Tm+7 | Tm+8 | Tm+9 | Tm+10 | Tm+11 | Tm+12 | Tm+13 | Tm+14 | Tm+15 |

CLK

CKE t_{CES} t_{CES}

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

BS

A10

A0-A9,A11

DQM

DQ   Hi-Z

t_{SB} t_{SREX} t_{RC}

All Banks
must be idle

Self Refresh   Power Down
Entry   Entry

Self Refresh
Exit

Power Down
Exit

Any Command

Discontinued (8/99 - last order; 12/99 - last ship)

Random Row Read (Interleaving Banks) with Precharge

($\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD}, t_{RP} = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

CKE — High

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RBx, RAx, RBy

A0-A9,A11 — RBx, CBx, RAx, CAx, RBy, CBy

DQM — t_{RCD}, t_{AC3}

DQ — Hi-Z, Bx0, Bx1, Bx2, Bx3, Bx4, Bx5, Bx6, Ax0, Ax1, Ax4, Ax5, Ax6, Ax7, By0

t_{CK3}

Activate Command Bank 1
Read Command Bank 1
Activate Command Bank 0
Read Command Bank 0
Precharge Command Bank 1
Activate Command Bank 1
Read Command Bank 1
Precharge Command Bank 0

* BS0=" L"
Bank2,3=Idle

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Random Row Read (Interleaving Banks) with Auto Precharge

($\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD}, t_{RP} = 3)

Timing diagram signals:

CLK, CKE (High), $\overline{CS}$, $\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, * BS1, A10, A0-A9,A11, DQM, DQ

Clock cycles: T0 T1 T2 T3 T4 T5 T6 T7 T8 T9 T10 T11 T12 T13 T14 T15 T16 T17 T18 T19 T20 T21 T22

t_{CK3}, t_{RCD}, t_{AC3}

CKE: Start Auto Precharge Bank 1; Start Auto Precharge Bank 0

A10: RBx, RAx, RBy

A0-A9,A11: RBx, CBx, RAx, CAx, RBy, CBy

DQ (Hi-Z): Bx0 Bx1 Bx2 Bx3 Bx4 Bx5 Bx6 Bx7 Ax0 Ax1 Ax4 Ax5 Ax6 Ax7 By0

Commands:
- Activate Command Bank 1
- Read with Auto Precharge Command Bank 1
- Activate Command Bank 0
- Read with Auto Precharge Command Bank 0
- Activate Command Bank 1
- Read with Auto Precharge Command Bank 1

* BS0=" L"

Bank2,3=Idle

Random Row Write (Interleaving Banks) with Auto Precharge

Discontinued (8/99 - last order; 12/99 - last ship)

($\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD}, t_{RP} = 3)

T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21	T22

CLK

t_{CK3}

CKE — High — Start Auto Precharge Bank 0 — Start Auto Pre-charge Bank 1

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RAx — RBx — RAy

A0-A9,A11 — RAx — CAX — RBx — CBx — RAy — CAy

DQM — t_{RCD}

DQ — Hi-Z — DAx0 DAx1 — DAx4 DAx5 DAx6 DAx7 DBx0 DBx1 DBx2 DBx3 DBx4 DBx5 — DBx6 DBx7 DAy0 DAy1

Activate Command Bank 0 — Write with Auto Precharge Command Bank 0 — Activate Command Bank 1 — Write with Auto Precharge Command Bank 1 — Activate Command Bank 0 — Write with Auto Precharge Command Bank 0

* BS0=" L"

Bank2,3=Idle

Random Row Write (Interleaving Banks) with Precharge

($\overline{\text{CAS}}$ Latency = 3; Burst Length = 8; t_{RCD}, t_{RP} = 3)

* BS0=" L"

Bank2,3=Idle

Read-Write Cycle

Discontinued (8/99 - last order; 12/99 - last ship)

($\overline{CAS}$ Latency = 3; Burst Length = 8; t_{RCD}, t_{RP} = 3)

| T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

t_{CK3}

CKE

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RAx

A0-A9,A11 — RAx   CAx   CAy

DQM

DQ   Hi-Z   Ax0 Ax1 Ax2 Ax3   DAy0 DAy1 DAy2 DAy3 DAy4

Activate
Command
Bank0

Read
Command
Bank 0

The Read Data
is Masked with a
Two Clock
Latency

Write
Command
Bank 0

The Write Data
is Masked with a
Zero Clock
Latency

Precharge
Command
Bank 0

* BS0=" L"
Bank2,3=Idle

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Interleaved Column Read Cycle

($\overline{CAS}$ Latency = 3; Burst Length = 4; t_{RCD}, t_{RP} = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

t_{CK3}

CKE — Start Auto Precharge Bank 0

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RAx, RBx

A0-A9,A11 — RAx, CAx, RBx, CBx, CBy, CBz, CAy

DQM — t_{RCD}, t_{AC3}

DQ — Hi-Z — Ax0, Ax1, Ax2, Ax3, Bx0, Bx1, By0, By1, Bz0, Bz1, Ay0, Ay1, Ay2, Ay3

Activate Command Bank 0

Read Command Bank 0

Activate Command Bank 1

Read Command Bank 1

Read Command Bank 1

Read Command Bank 1

Read with Auto Precharge Command Bank 0

Precharge Command Bank 1

* BS0="L"
Bank2,3=Idle

Discontinued (8/99 - last order; 12/99 - last ship)

Auto Precharge after Read Burst

(CAS Latency = 3; Burst Length = 4; t_{RCD}, t_{RP} = 3)
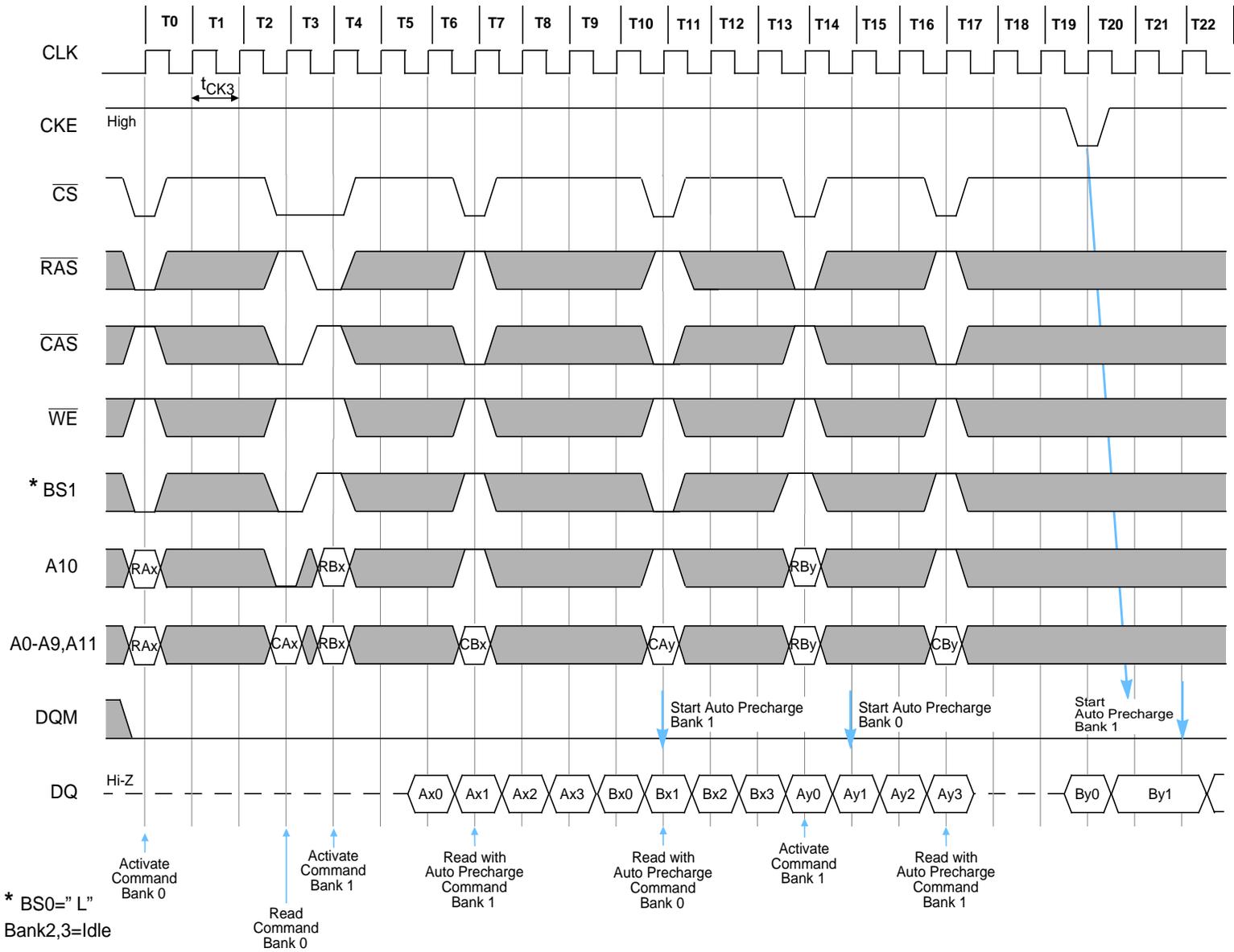
| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

t_{CK3}

CKE — High

CS

RAS

CAS

WE

* BS1

A10 — RAx, RBx, RBy

A0-A9,A11 — RAx, CAx, RBx, CBx, CAy, RBy, CBy

DQM — Start Auto Precharge Bank 1 / Start Auto Precharge Bank 0 / Start Auto Precharge Bank 1

DQ — Hi-Z — Ax0, Ax1, Ax2, Ax3, Bx0, Bx1, Bx2, Bx3, Ay0, Ay1, Ay2, Ay3, By0, By1

Activate Command Bank 0

Read Command Bank 0

Activate Command Bank 1

Read with Auto Precharge Command Bank 1

Read with Auto Precharge Command Bank 0

Activate Command Bank 1

Read with Auto Precharge Command Bank 1

* BS0=" L"
Bank2,3=Idle

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Auto Precharge after Write Burst

$\overline{CAS}$ **Latency = 2; Burst Length = 4)**

CLK	T0 T1 T2 T3 T4 T5 T6 T7 T8 T9 T10 T11 T12 T13 T14 T15 T16 T17 T18 T19 T20 T21 T22

t_{CK2}

CKE — High

Start Auto Precharge Bank 1
Start Auto Precharge Bank 0
Start Auto Precharge Bank 1
Start Auto Precharge Bank 0

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

* BS1

A10 — RAx RBx RBy RAz

A0-A9,A11 — RAx CAx RBx CBx CAy RBy CBy RAz CAz

DQM

DQ — Hi-Z DAx0 DAx1 DAx2 DAx3 DBx0 DBx1 DBx2 DBx3 DAy0 DAy1 DAy2 DAy3 DBy0 DBy1 DBy2 DBy3 DAz0 DAz1 DAz2 DAz3

Activate Command Bank 0
Write Command Bank 0
Activate Command Bank 1
Write with Auto Precharge Command Bank 1
Write with Auto Precharge Command Bank 0
Activate Command Bank 1
Write with Auto Precharge Command Bank 1
Activate Command Bank 0
Write with Auto Precharge Command Bank 0

* BS0=" L"
Bank2,3=Idle

Burst Read and Single Write Operation

Discontinued (8/99 - last order; 12/99 - last ship)

($\overline{\text{CAS}}$ Latency = 2; Burst Length = 4)

IBM
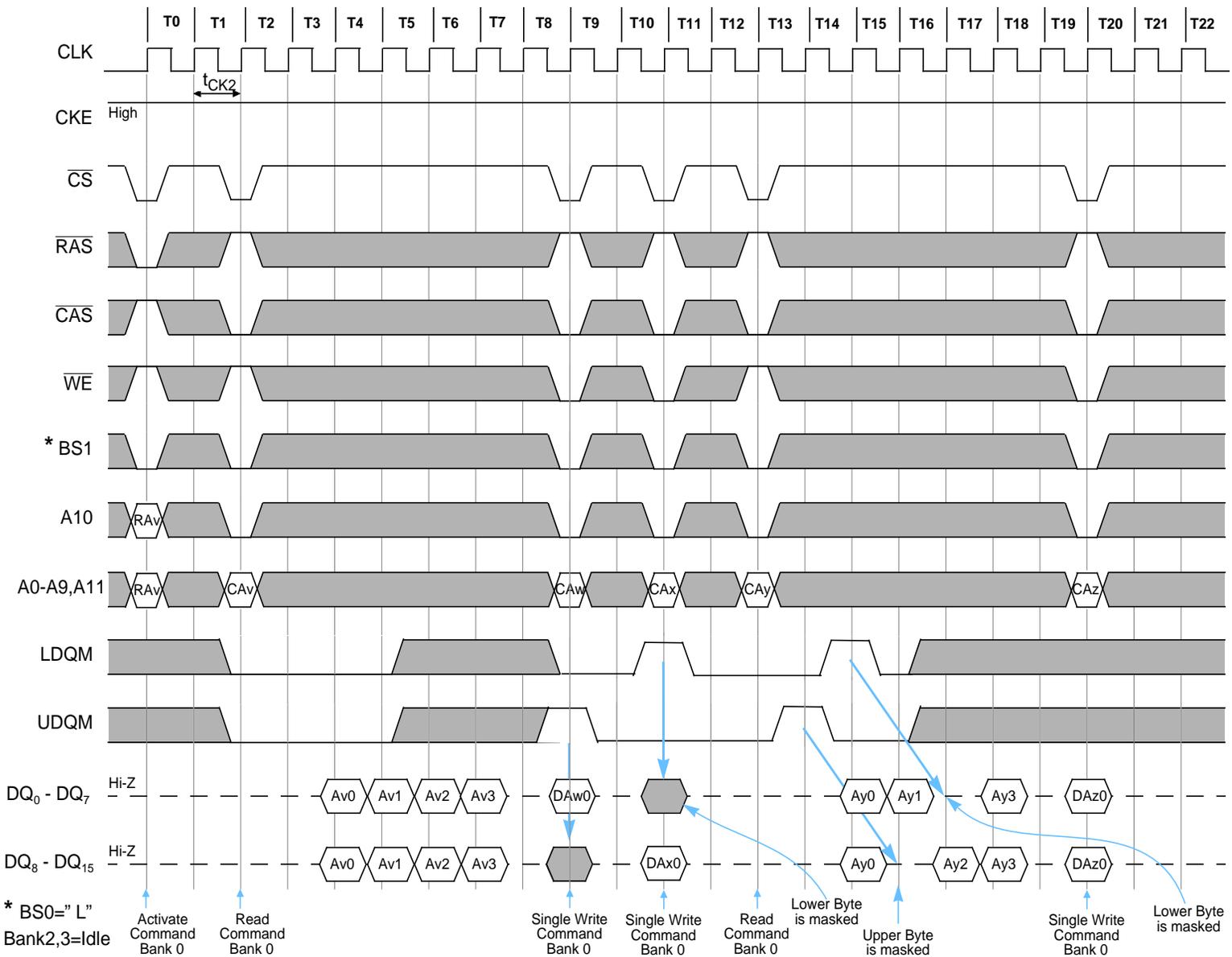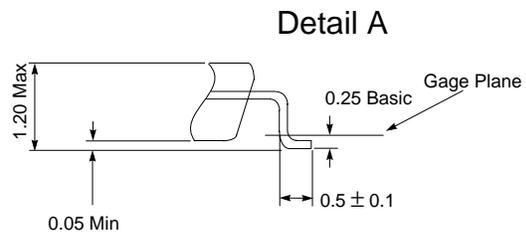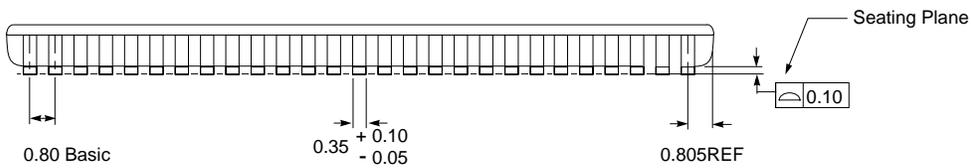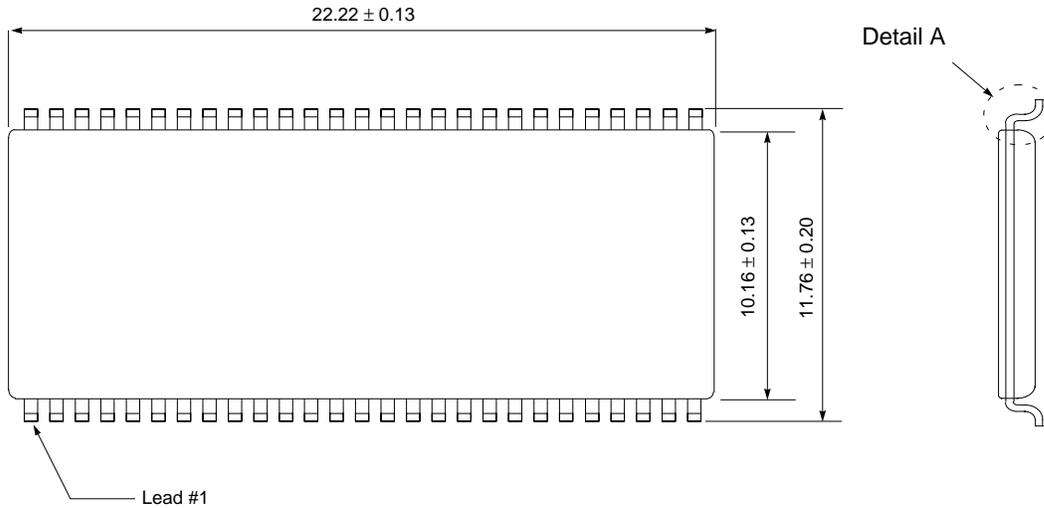
Full Page Burst Read and Single Write Operation

IBM0364804
IBM0364164
IBM0364404
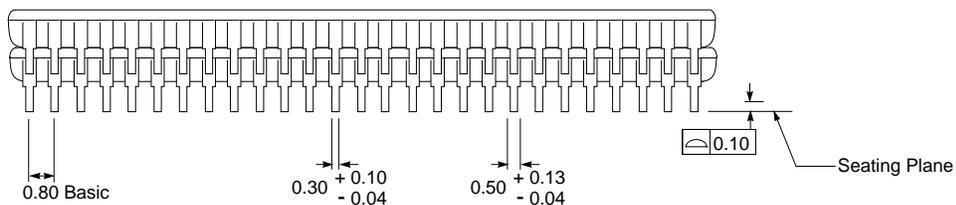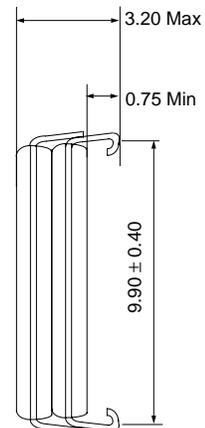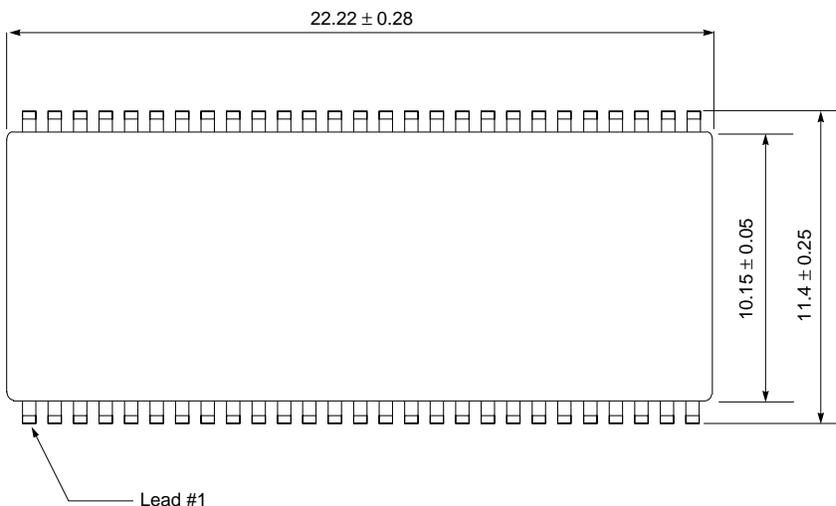IBM0364484

IBM0364B4

64Mb Synchronous DRAM - Die Revision B

($\overline{\text{CAS}}$ Latency = 3; Burst Length = Full Page; t_{RCD}, t_{RP} = 3)
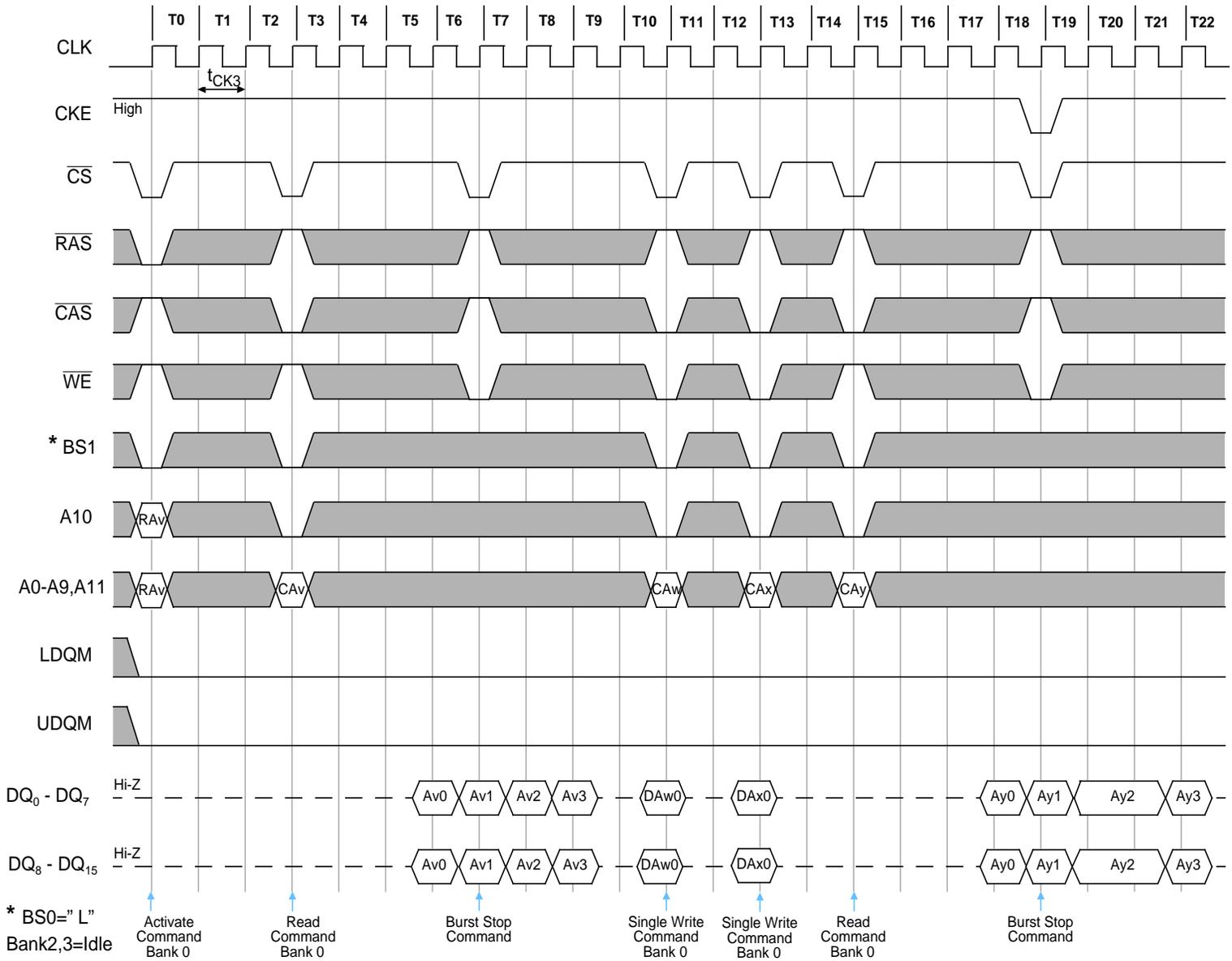
	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21	T22

* BS0=" L"
Bank2,3=Idle

Activate Command Bank 0 · Read Command Bank 0 · Burst Stop Command · Single Write Command Bank 0 · Single Write Command Bank 0 · Read Command Bank 0 · Burst Stop Command

Discontinued (8/99 - last order; 12/99 - last ship)

(At 100MHz $\overline{CAS}$ Latency = 3; Burst Length = 4; t_{RCD}, t_{RP} = 3)

$\overline{CS}$ Function (Only $\overline{CS}$ signal needs to be asserted at minimum rate)

| T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 | T22 |

CLK

t_{CK3}

CKE

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

$\overline{WE}$

A11(BS)

A10 — RAx

A0 - A9 — RAx   CAx   CAy

DQM — Low

DQ — Hi-Z t_{RCD} Ax0 Ax1 Ax2 Ax3   DAy0 DAy1 DAy2 DAy3

Activate
Command
Bank A

Read
Command
Bank A

Write
Command
Bank A

Precharge
Command
Bank A

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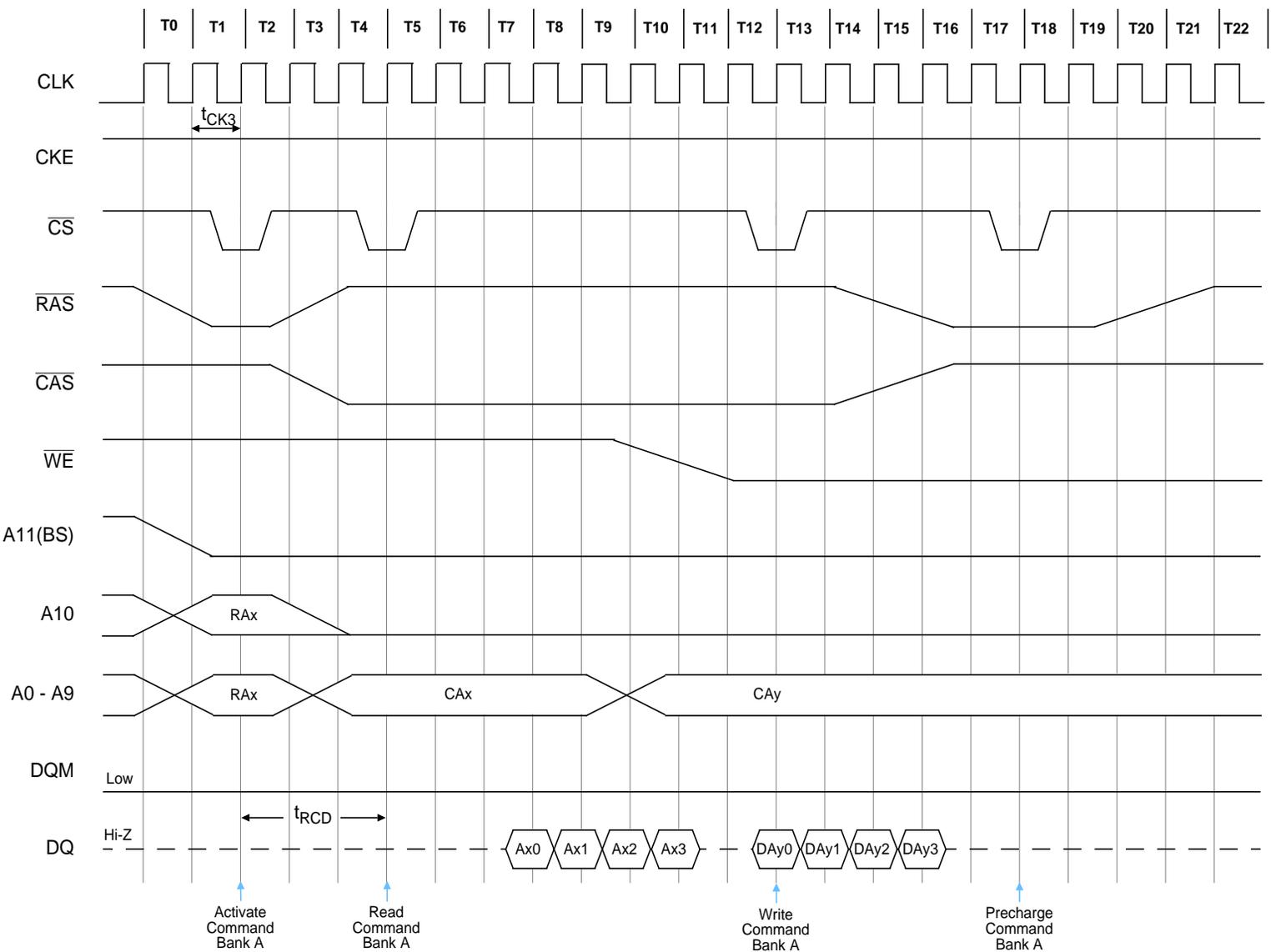
IBM0364804   IBM0364164
IBM0364404   IBM03644B4
64Mb Synchronous DRAM - Die Revision B

Package Dimensions (400mil; 54 lead; Thin Small Outline Package)

22.22 ± 0.13

Detail A

10.16 ± 0.13

11.76 ± 0.20

Lead #1

Seating Plane

0.10

0.80 Basic

$0.35 \; {}^{+\,0.10}_{-\,0.05}$

0.805REF

Detail A

1.20 Max

0.25 Basic

Gage Plane

0.05 Min

0.5 ± 0.1

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IBM0364804   IBM0364164
IBM0364404   IBM03644B4
64Mb Synchronous DRAM - Die Revision B

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Package Dimensions (400mil; 54 lead; 2 High Stack; Thin Small Outline J Lead Package)

22.22 ± 0.28

3.20 Max

0.75 Min

9.90 ± 0.40

10.15 ± 0.05

11.4 ± 0.25

Lead #1

0.80 Basic

0.30 +0.10 / -0.04

0.50 +0.13 / -0.04

0.10

Seating Plane

IBM0364804   IBM0364164
IBM0364404   IBM03644B4
64Mb Synchronous DRAM - Die Revision B

Revision Log

Revision		Contents of Modification
12/1/97		Initial release.
2/9/98	page 7	Change ordering information: -322 -> -360, -222 -> -260
	page 31	Clarify Power Down Mode.
	page 43	Change test conditions, notes.
3/18/98	page 43	Change I_{CC2N}, I_{CC3N}, I_{CC4} for -260, -360 (t_{CK3} changed from 8ns to 10ns).
	page 44	Change timing parameters: t_{CK3}, t_{SB}, t_{RAS}, t_{RRD}, t_{RSC}, t_{HZ}, t_{DPL3} (t_{CK3} changed from 8ns to 10ns).
4/6/98	page 43	Update currents, add low power current specification.
4/30/98	page 50	Correct A10 from low to high in read with auto precharge (bank 0). Also, page 51 and page 52.
5/1/98	page 3	Add -68; changed CL=3 timings (-260, -360) and CL=2 timings (-260) to encompass JEDEC 125 MHz requirements. Also, page 7, page 44-page 46.
	page 25	Add note for -68 t_{DPL} (2 clocks) and/or update wording. Also, page 29, page 62. Update wording and/or -260/-360 note (t_{CK3}=10). Also, page 26, page 28.
	page 41	Include minimum capacitance specification, update maximum for CLK.
	page 42	Update leakage current limit (5 -> 2µA)
	page 43	Update currents based on timing changes.
	page 46	Add Clock Frequency and Latency table.
	page 49	Add timing diagram. Also, page 70.
	page 51	Correct CKE. Also, page 52.
	page 52	Add note: $t_{RAS(min)}$.
5/29/98	page 3	Changed -360 timings from 125MHz to 100MHz. Also, page 7, page 44-page 46.
	page 22	Clarify Read with auto-precharge description.
7/8/98	page 43	Change I_{CC5} for -260 to be consistent with -360 (lower existing values by 5 mA).
	page 45	Clarify t_{OH} / load conditions across speed sorts.
7/14/98	page 34	Change $\overline{WE}$ in Self Refresh Exit Command from "X" to "H" (NOP).
	page 44	Correct t_{CKH}, t_{CKL} for -68 (3.0->2.4).
	page 51	Correct Read (322) timing: Auto-precharge start, extend t_{RCD} to 3 clocks.
1/28/99	page 3	Change -260/-360 to 135MHz max. Also page 44-page 46.
	page 7	Remove x4, -68; and x16, -260.
	page 25	Remove note about -68 t_{DPL}. Also page 29 and page 62.
	page 31	Correct Power Down Exit timing.
	page 35	Change $\overline{WE}$ in Power Down Entry/Exit from "X" to "H." Update note 7, NOP required.
	page 36	Update note 2, NOP required.
	page 41	Corrected maximum DQ capacitance (5.0 -> 6.5); added "typical" column to table.
	page 43	Update currents to reflect change in performance. Also, update I_{CC3P} (3->7); remove LP for I_{CC2P}, I_{CC2PS}, I_{CC5}.
	pages 44-46	Update timings (7.4ns t_{CK}).
	page 51	Clarify note about t_{RAS}(min).
	page 61	Correct timing diagram (last activate/read timing).

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